

**19th Congress of the International Commission for Optics**  
**Firenze, 25-30 August 2002**



Centro Ricerche Portici



**Camera for recording light backscattered  
from photovoltaic samples**

**Antonio Parretta**

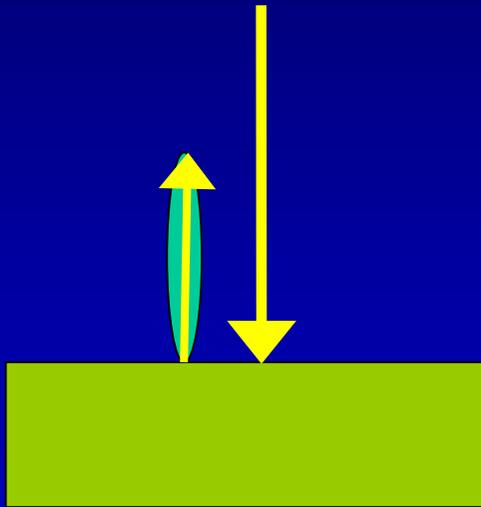
*ENEA Research Centre.*

*Località Granatello. I-80055 Portici (Na), Italy.*

# INTRODUCTION

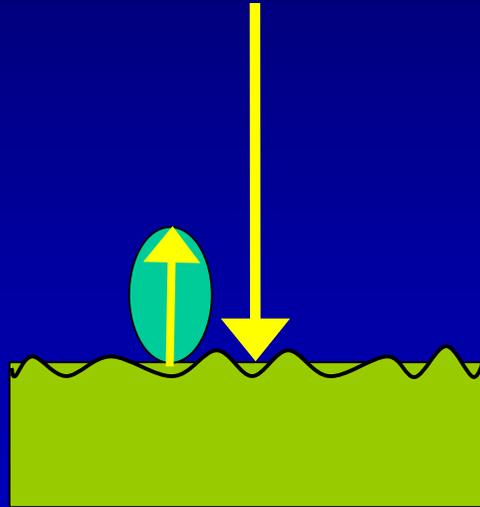
# LIGHT BACKSCATTERING FROM PHOTOVOLTAIC SURFACES

Flat silicon surface



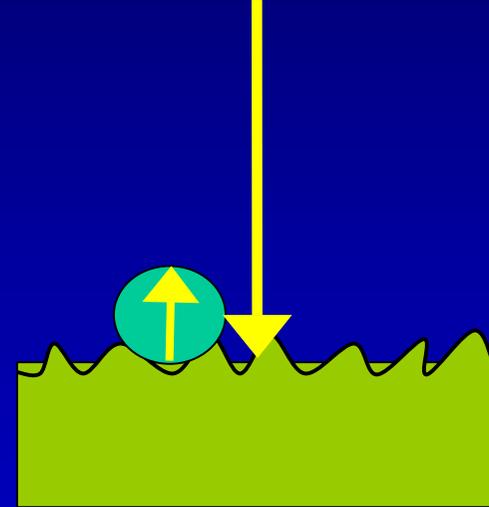
High total reflectance

Rough silicon surface



Medium reflectance

Very rough silicon surface

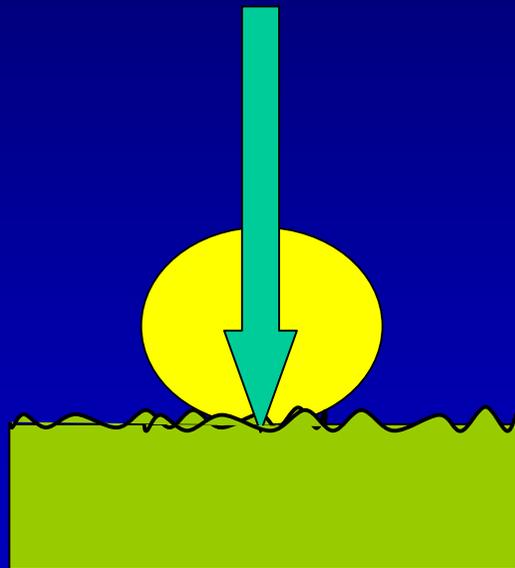


Low total reflectance

*Surface roughness promotes light trapping and produces spatially distributed reflected light*

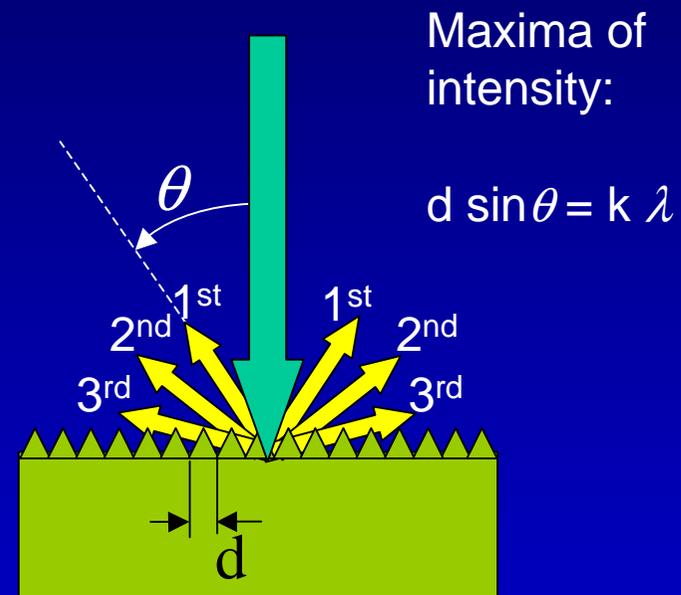
# LIGHT BACKSCATTERING FROM PHOTOVOLTAIC SURFACES

Light diffusion



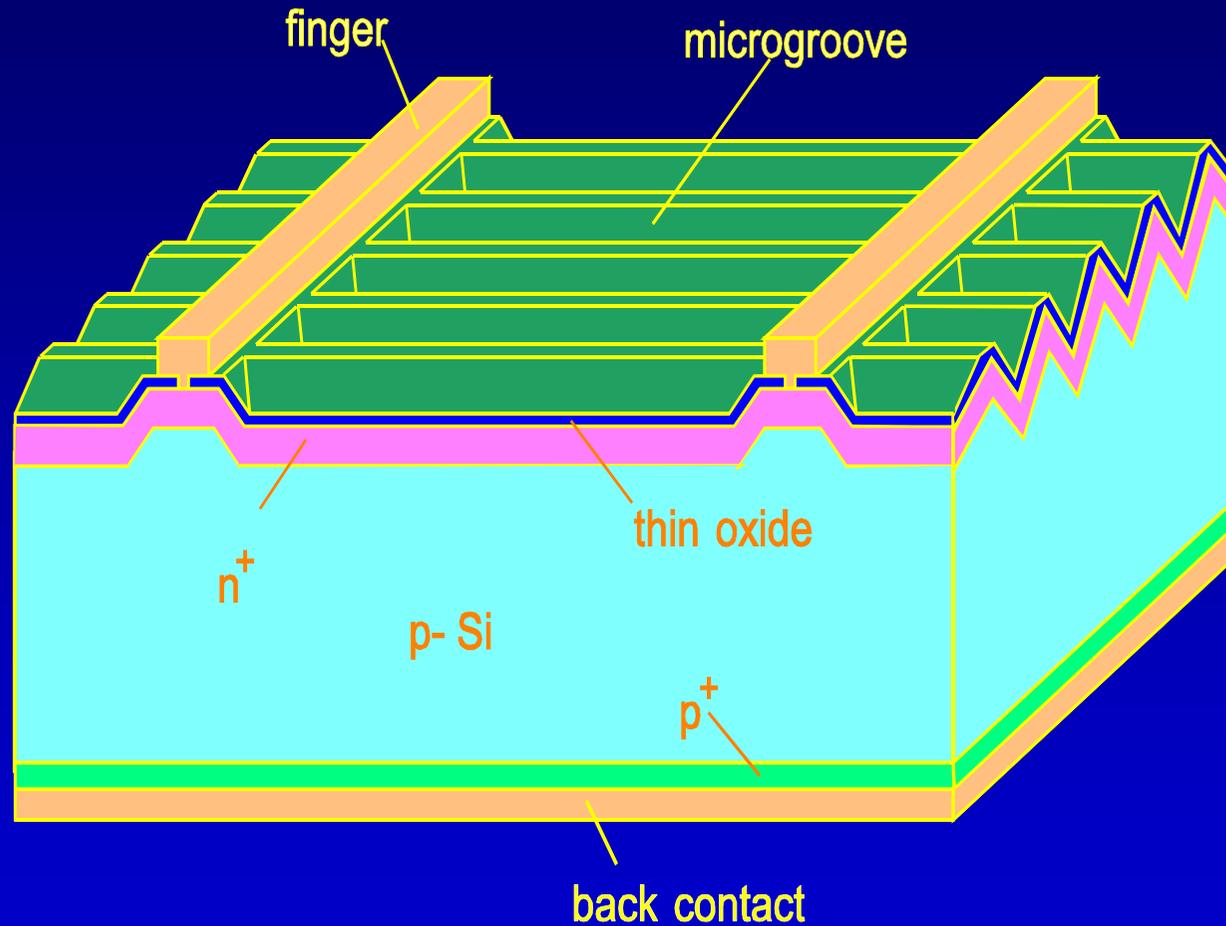
Randomly textured surface

Light diffraction



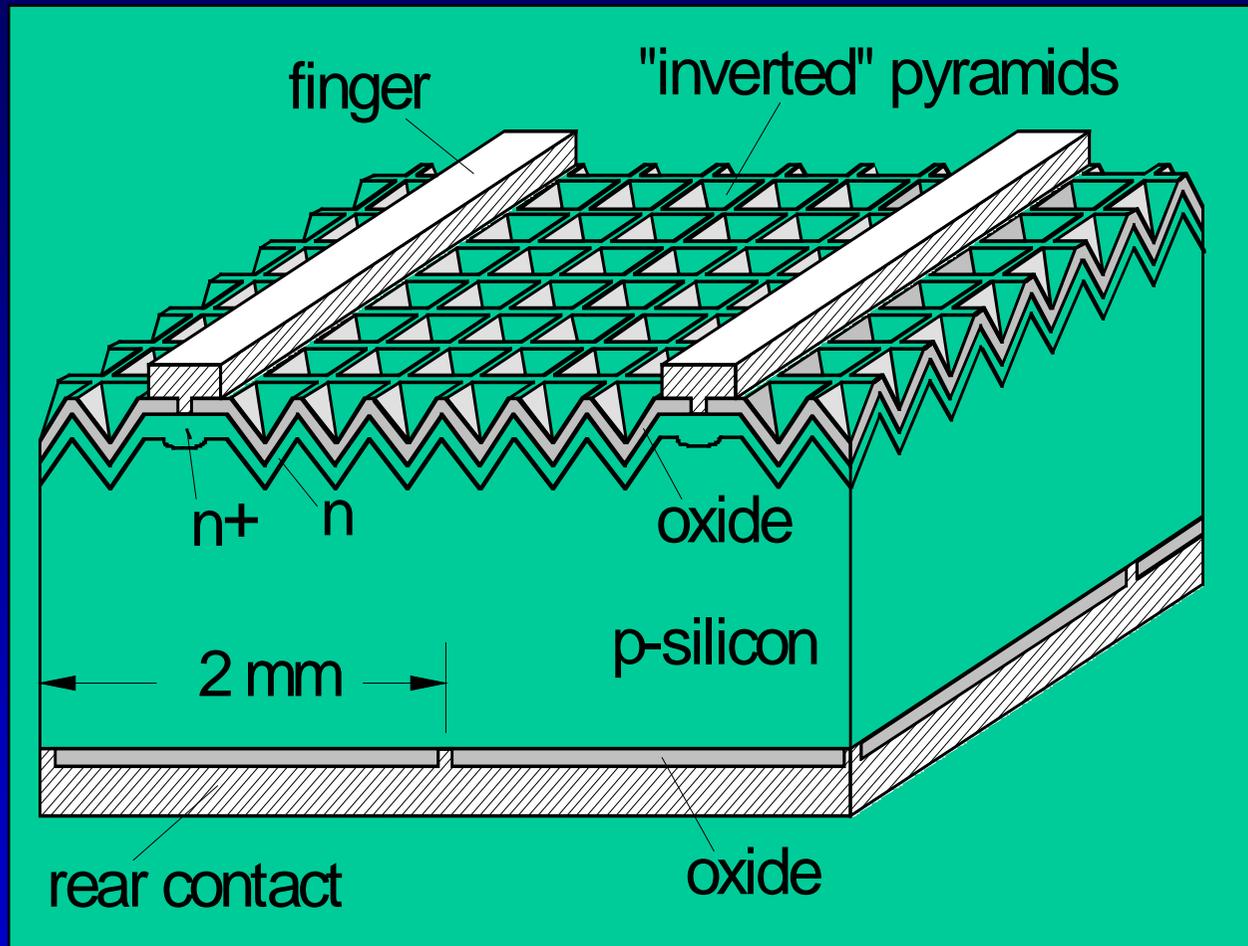
Regularly textured surface

## EXAMPLES OF REGULARLY TEXTURED SILICON SURFACES (from UNSW)



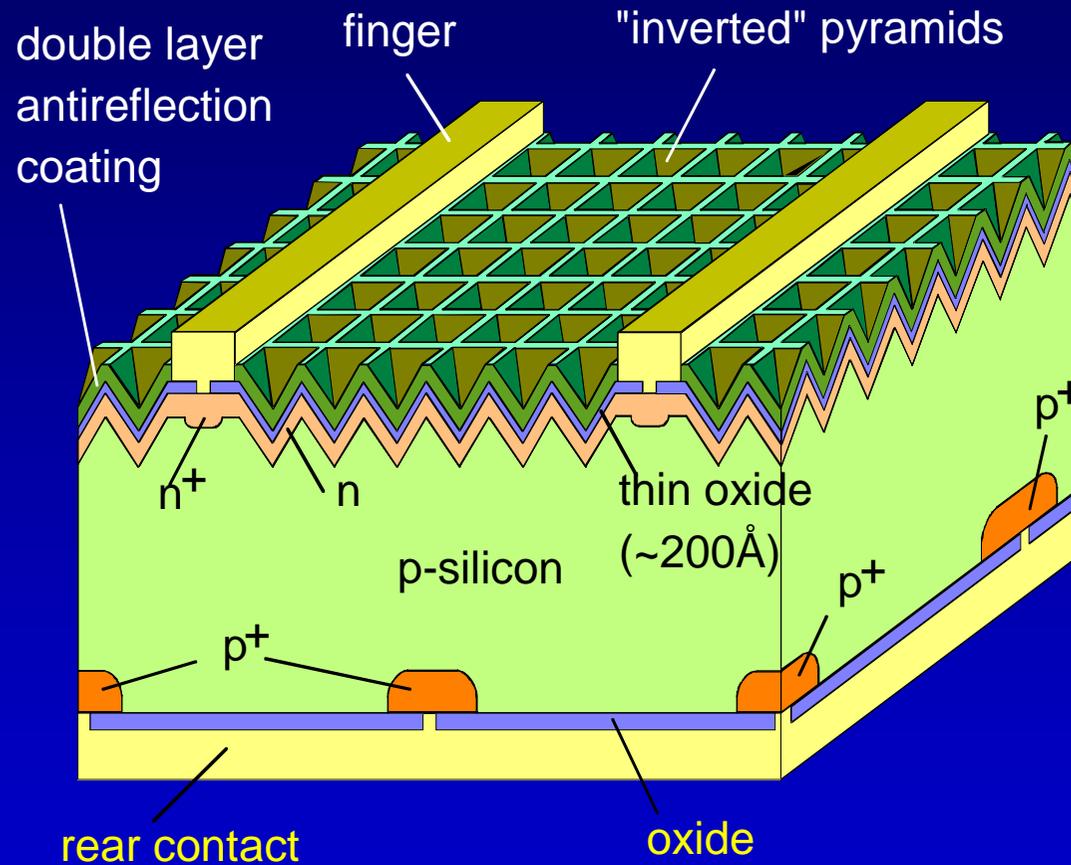
*PESC (Passivated Emitter Solar Cell)*

## EXAMPLES OF REGULARLY TEXTURED SILICON SURFACES (from UNSW)



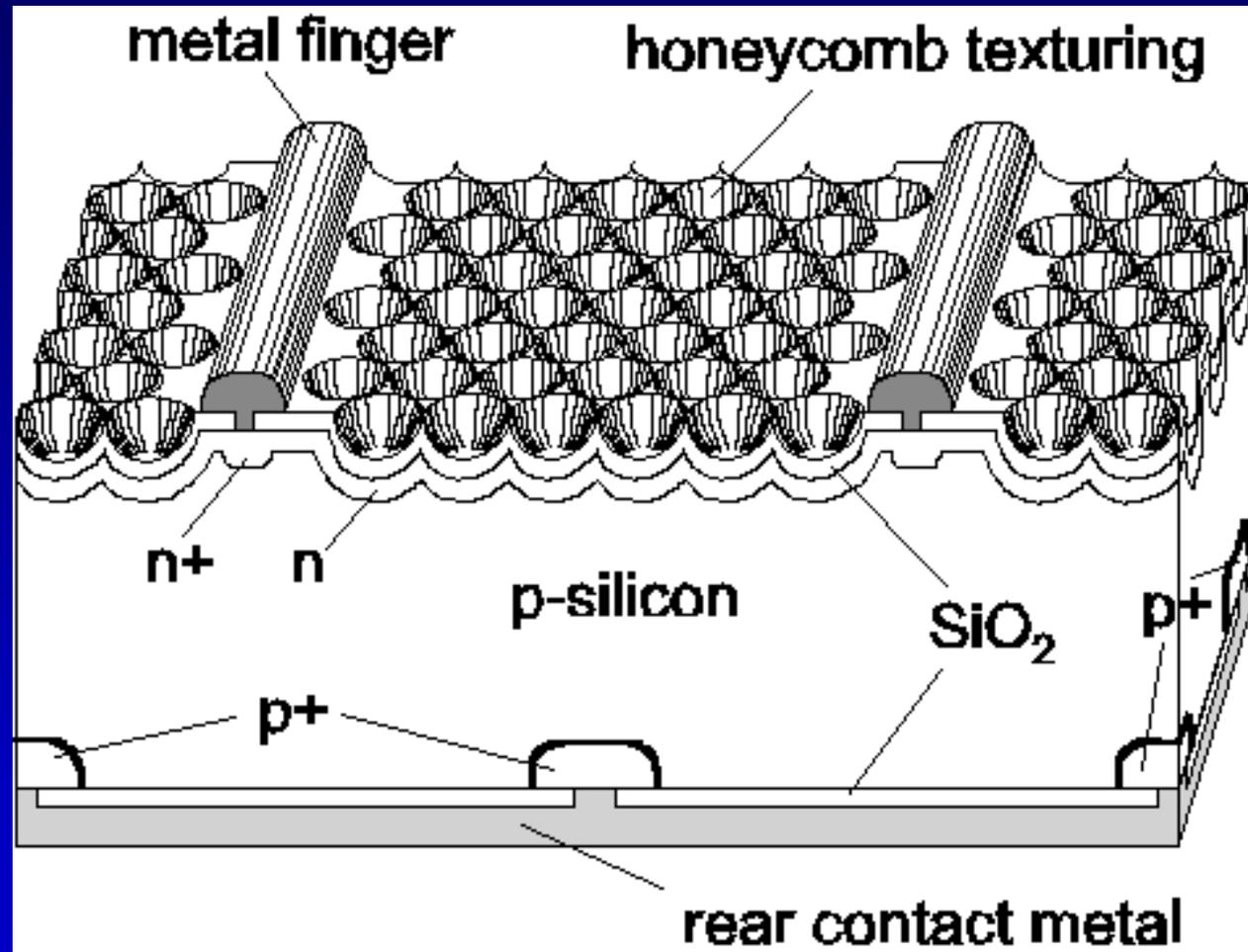
*PERC (passivated emitter and rear cell)*

## EXAMPLES OF REGULARLY TEXTURED SILICON SURFACES (from UNSW)



*PERC (Passivated Emitter, Rear Locally-diffused cell)*

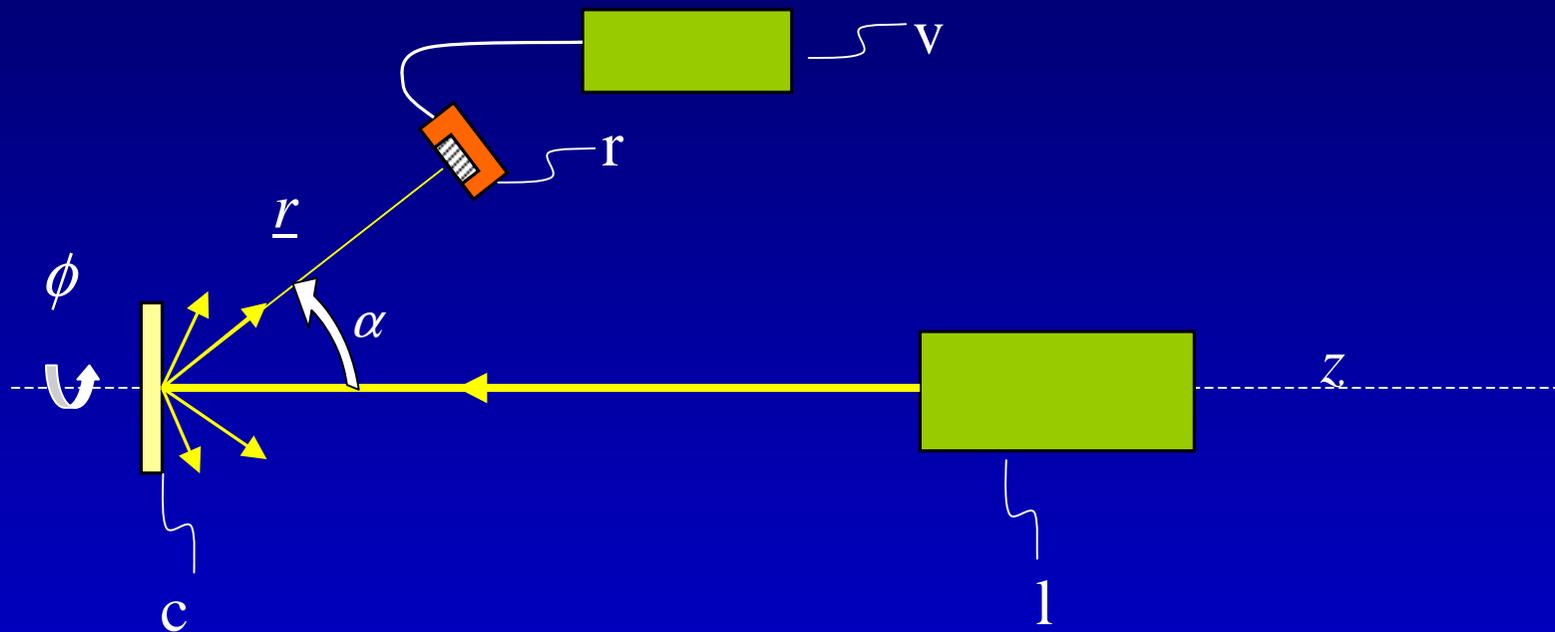
## EXAMPLES OF REGULARLY TEXTURED SILICON SURFACES (from UNSW)



*HC (Honeycomb textured multi-Si cell)*

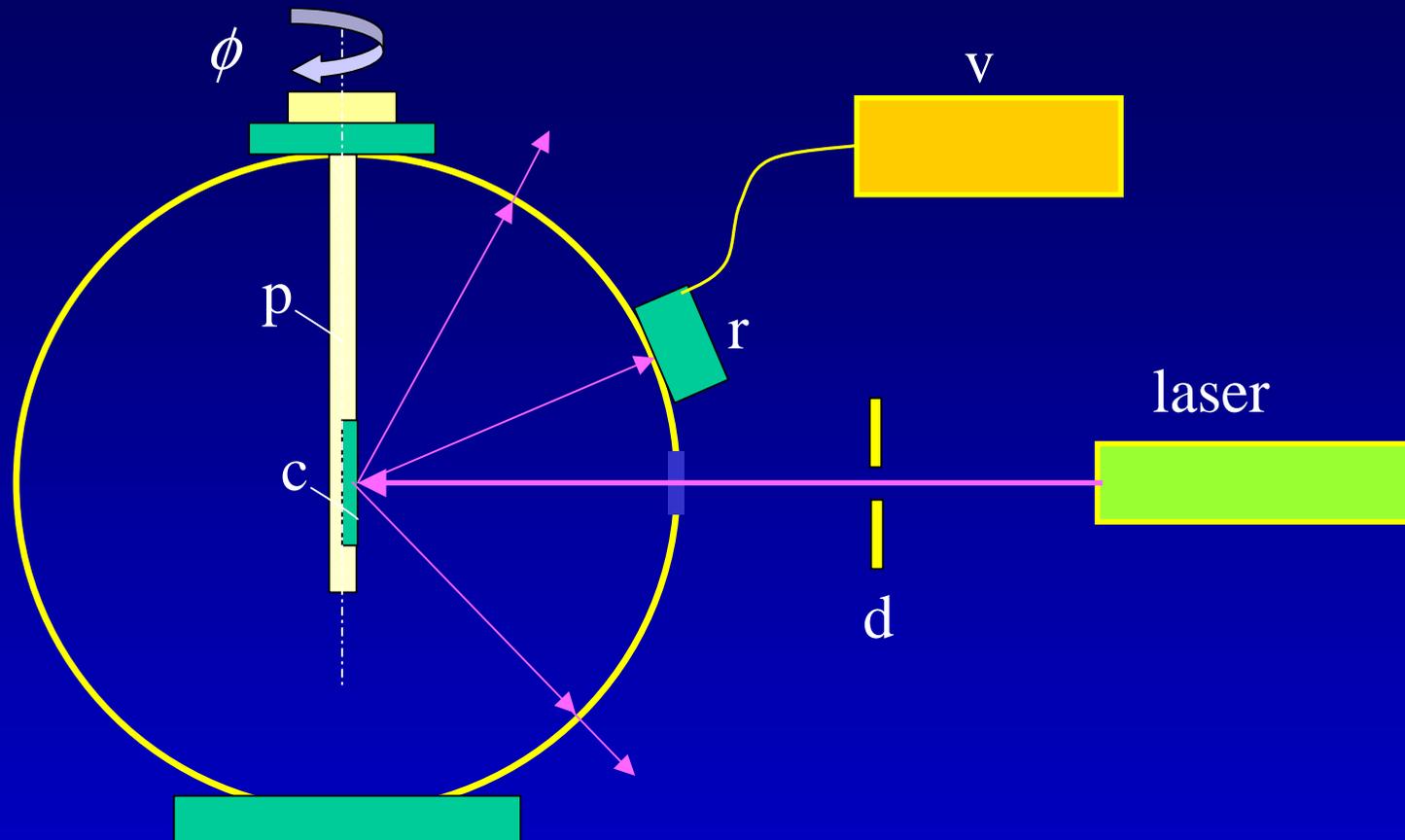
**MEASUREMENT OF LIGHT BACKSCATTERED  
FROM PHOTOVOLTAIC SURFACES**

# TWO-GONIOMETERS APPARATUS



The detector is moved in front of the sample, at constant distance, changing angles  $\alpha$  and  $\phi$  by two goniometers.

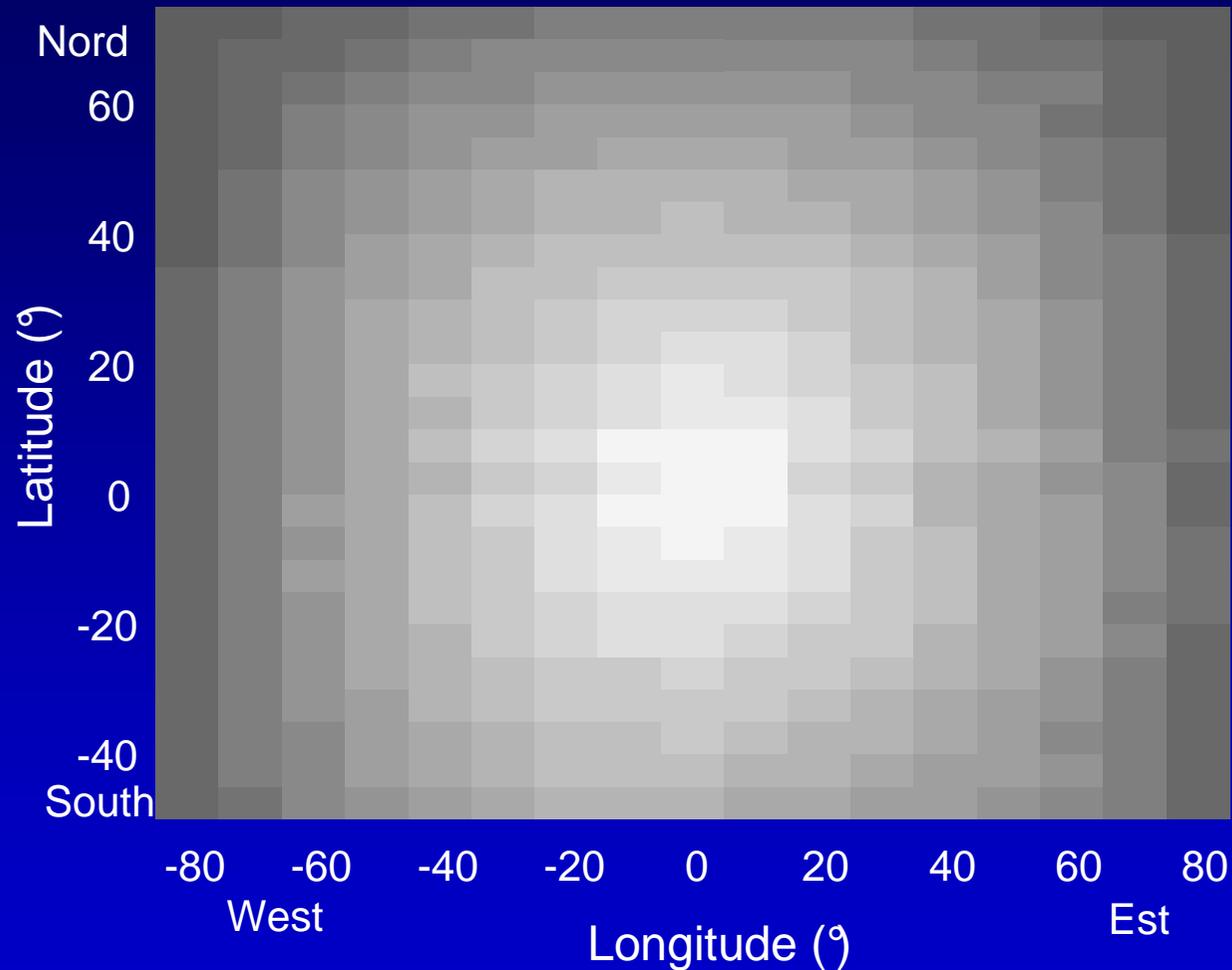
# SEMITRANSSPARENT GLOBE



Simple apparatus for backscattered light measurements.  
The photodetector is moved over the globe surface.

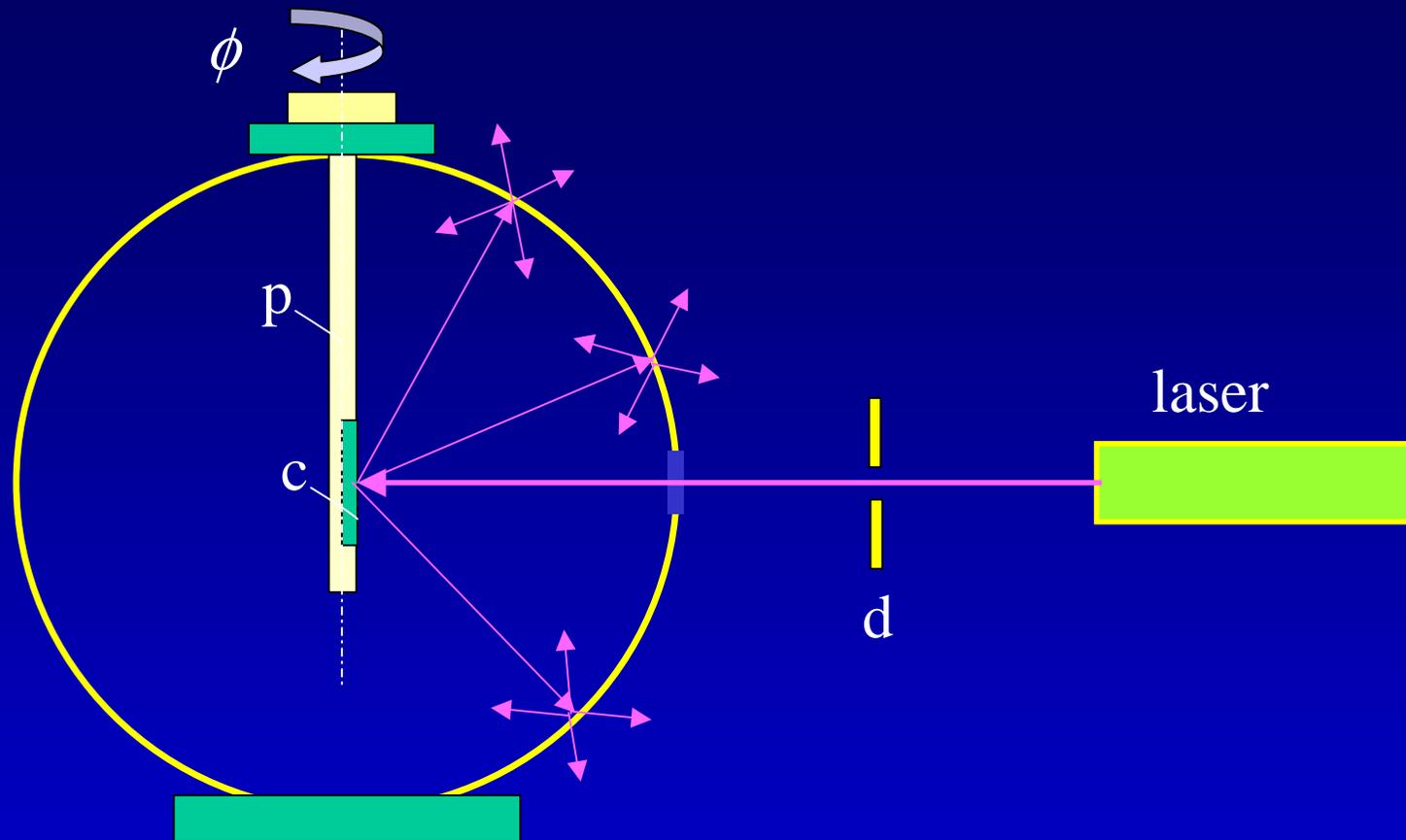
# SEMITRANSSPARENT GLOBE

Porous Si, 40  $\mu\text{m}$ , n-type



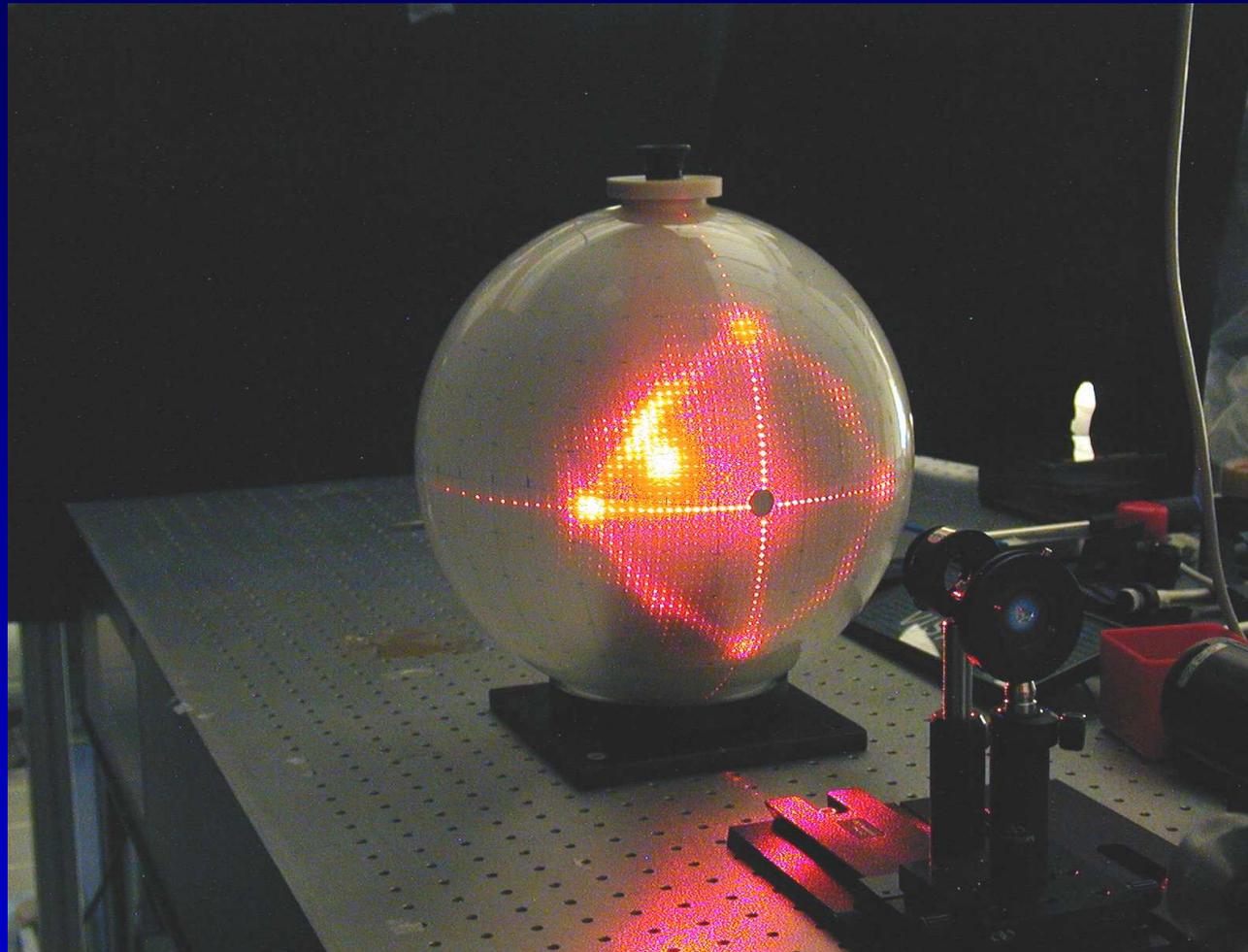
Map of light intensity backscattered by a porous-Si sample  
(Laser light  $\lambda=633$  nm;  $0^\circ$  incidence).

# VISUALIZING GLOBE



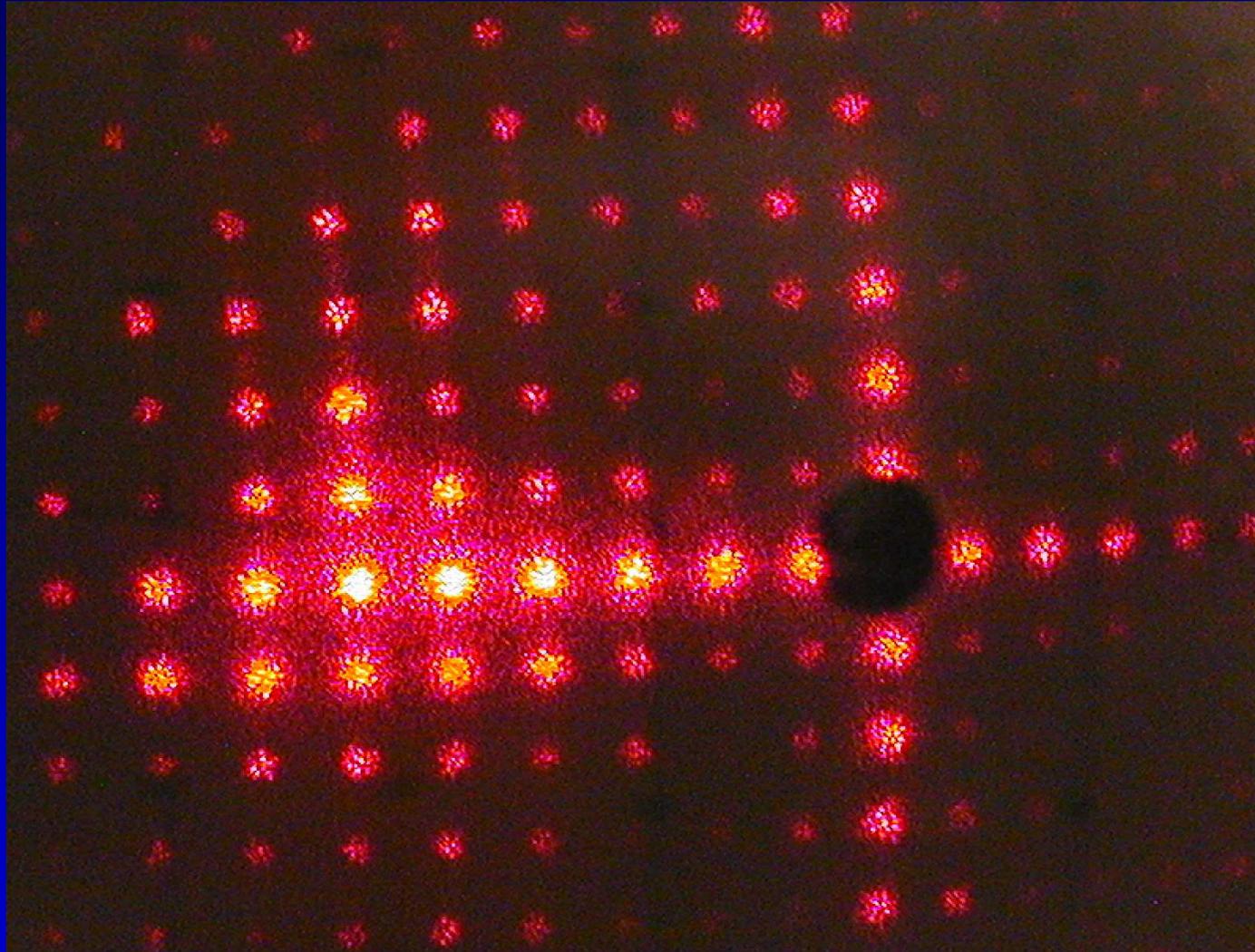
The plastic globe is internally sand-blasted in order to scatter, and then visualize, the light backscattered by the sample.

## VISUALIZING GLOBE



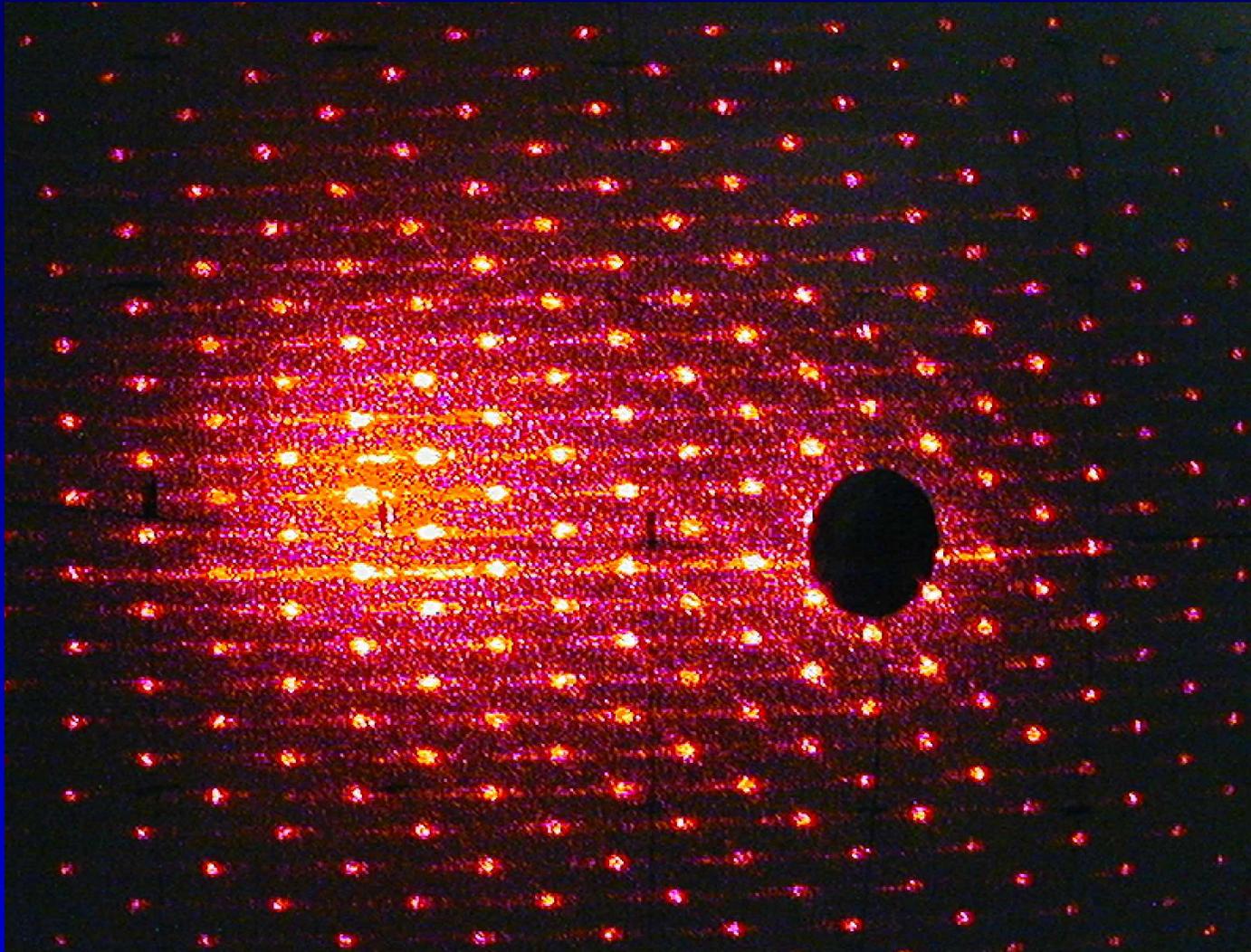
The sand-blasted globe shows the light backscattering figure produced by a solar cell textured by inverted pyramids (Fraunhofer).

## VISUALIZING GLOBE



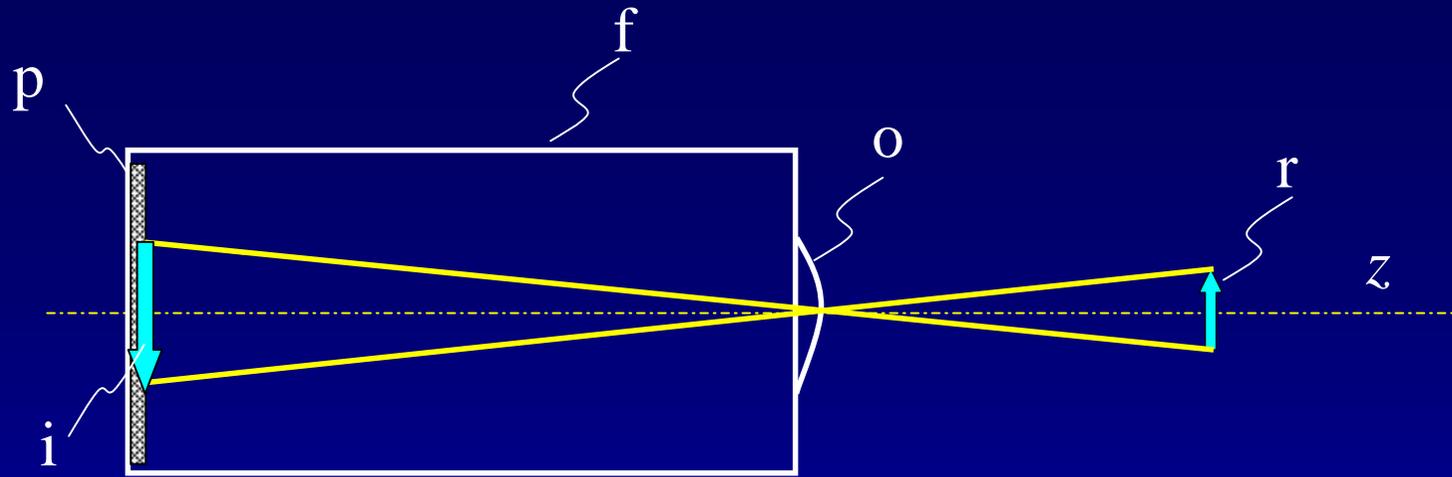
Particular of the light diffraction figure (LDF) produced by inverted pyramids texture.

## VISUALIZING GLOBE

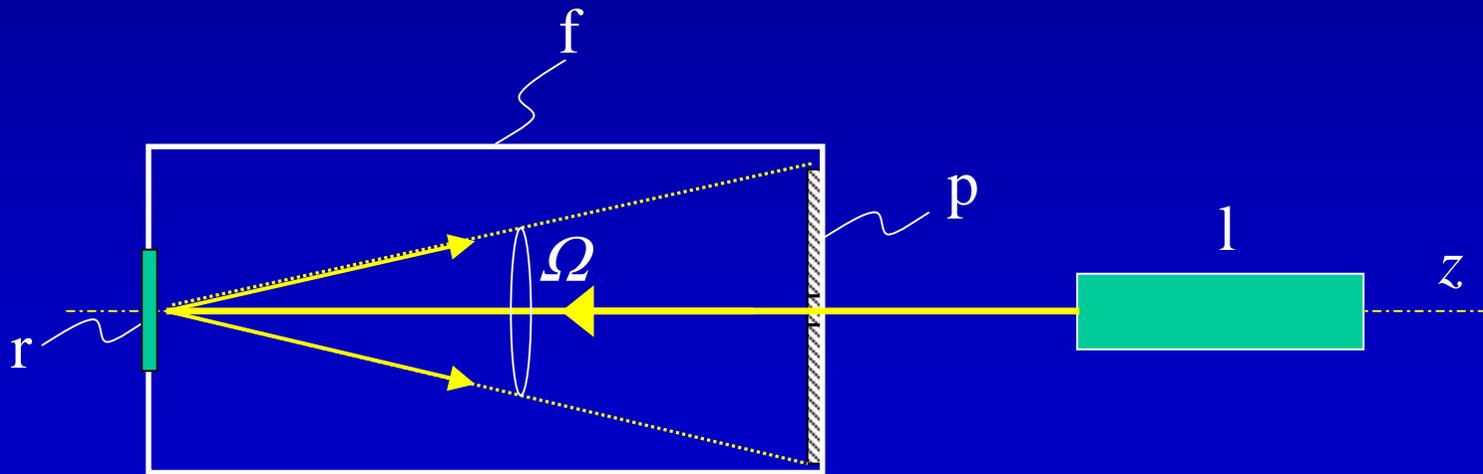


Particular of the light diffraction figure (LDF) produced by a honeycomb textured cell (UNSW).

**PHOTOCAMERA FOR RECORDING  
THE BACKSCATTERED LIGHT**

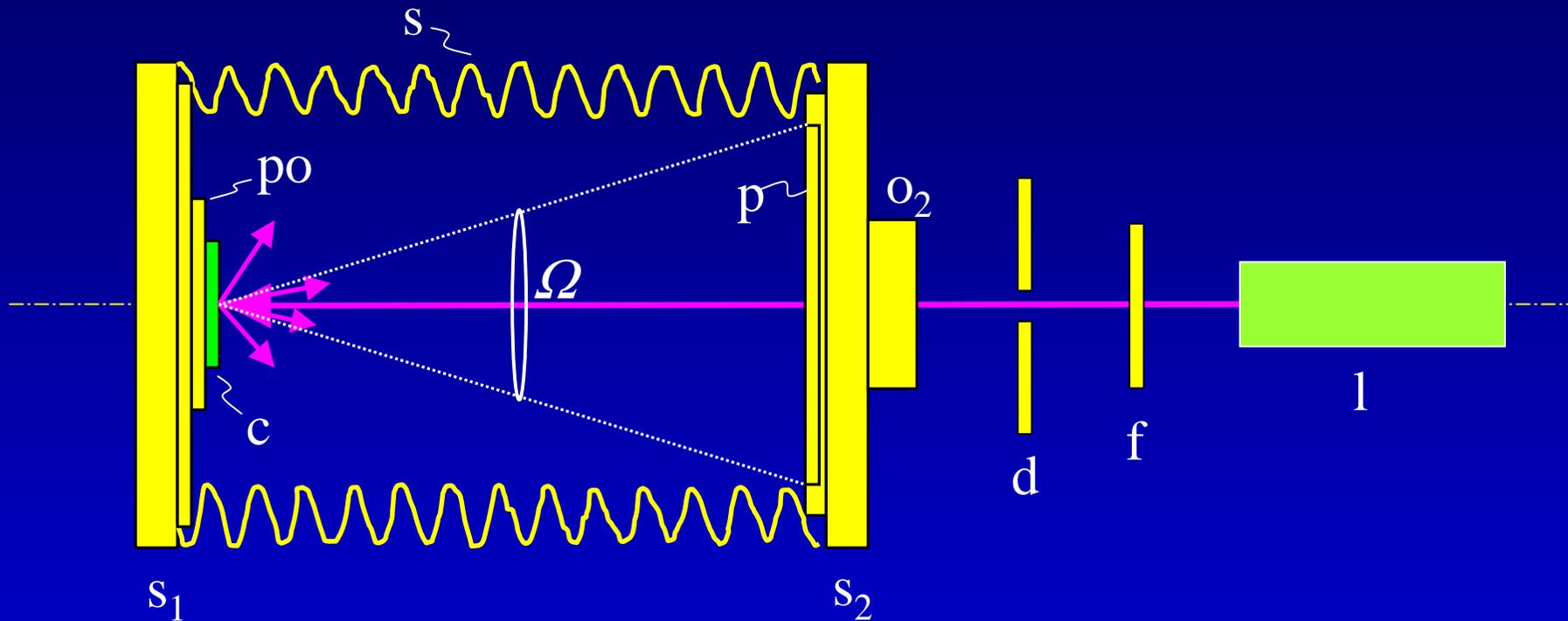


Normal (refraction) photocamera



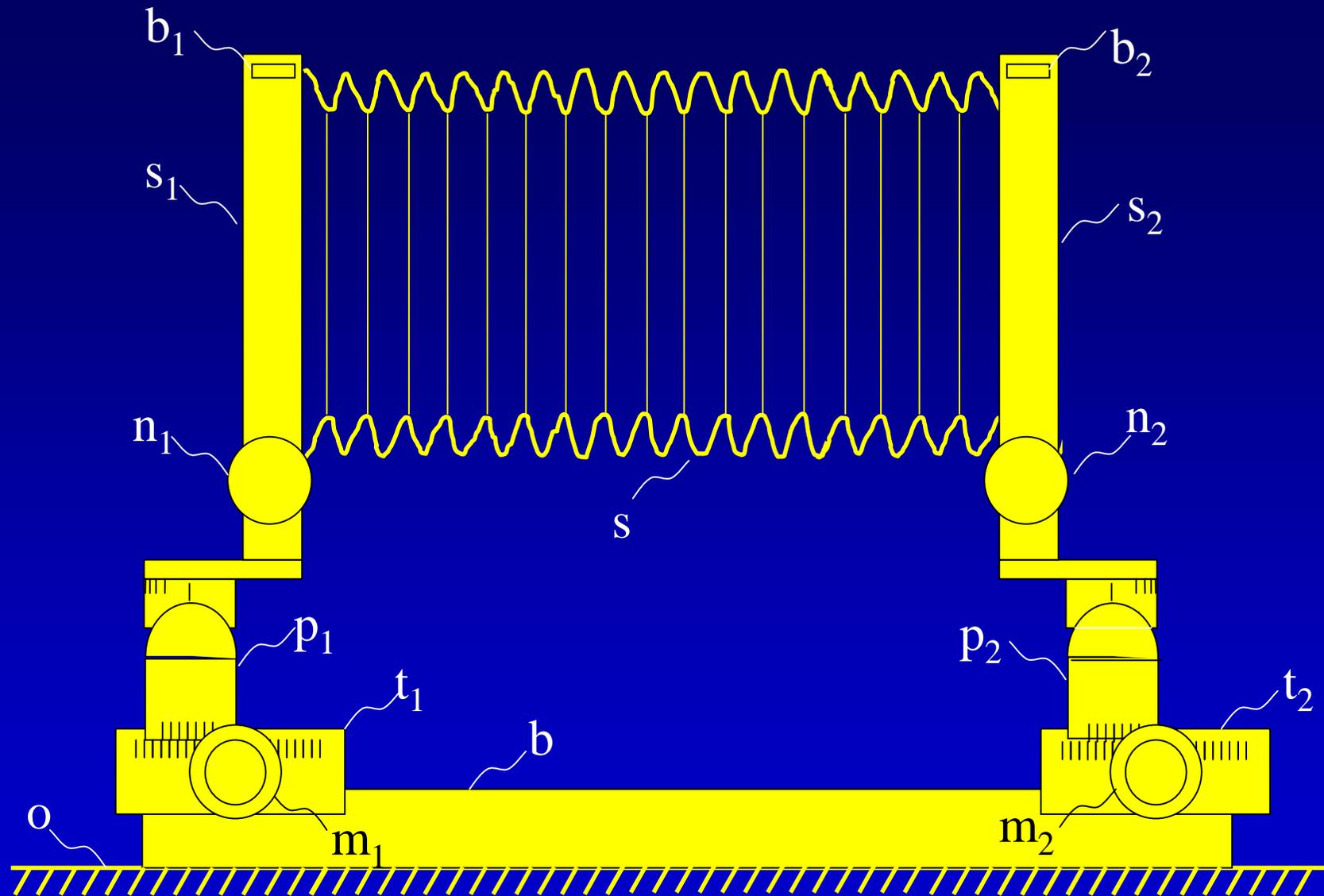
CARDIFF (scattering) photocamera

# PHOTOCAMERA CARDIFF (patented) (Camera for Recording DIFFused and DIFFracted light)



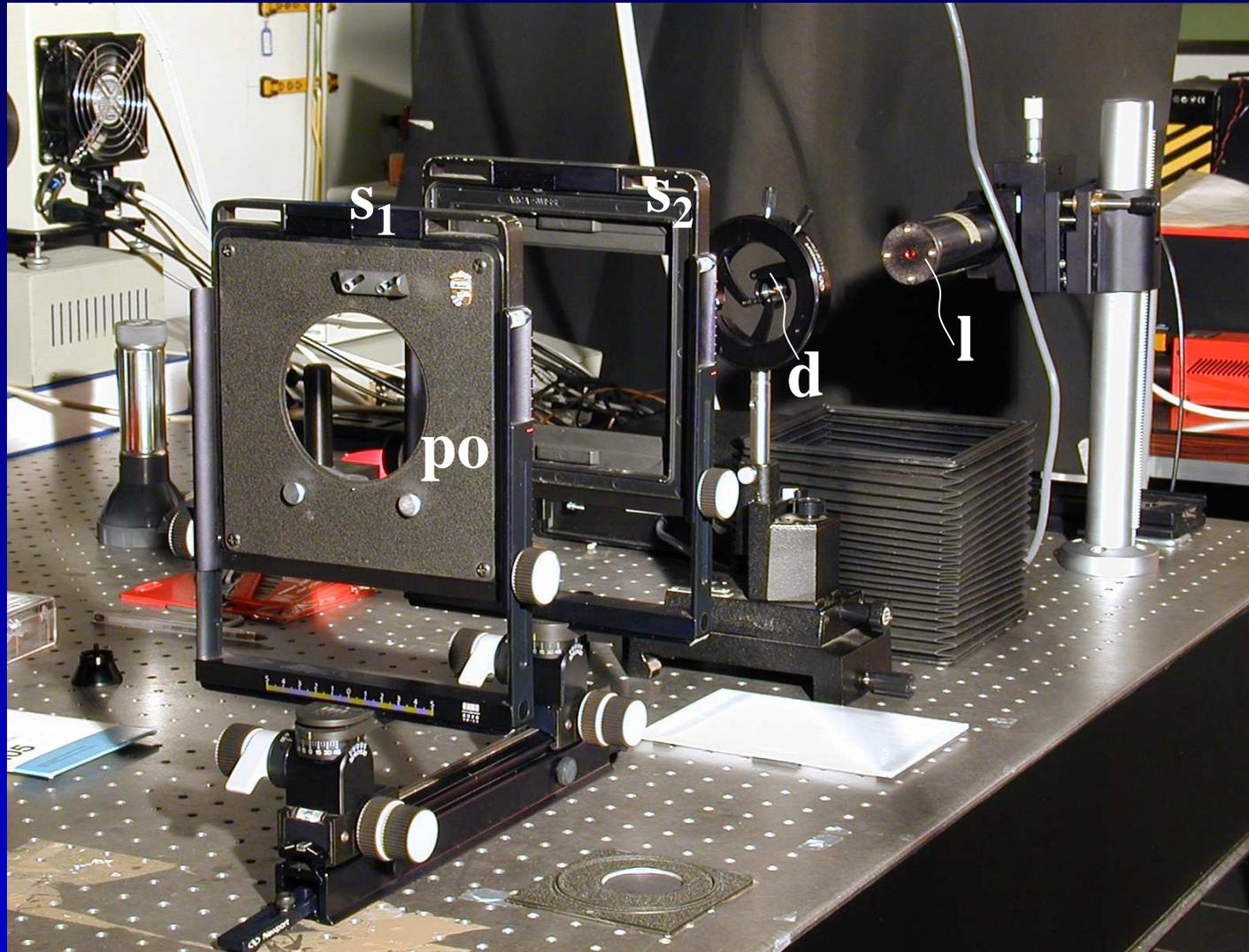
Schematics of the CARDIFF apparatus for recording light backscattered from small textured photovoltaic samples.

# PHOTOCAMERA CARDIFF



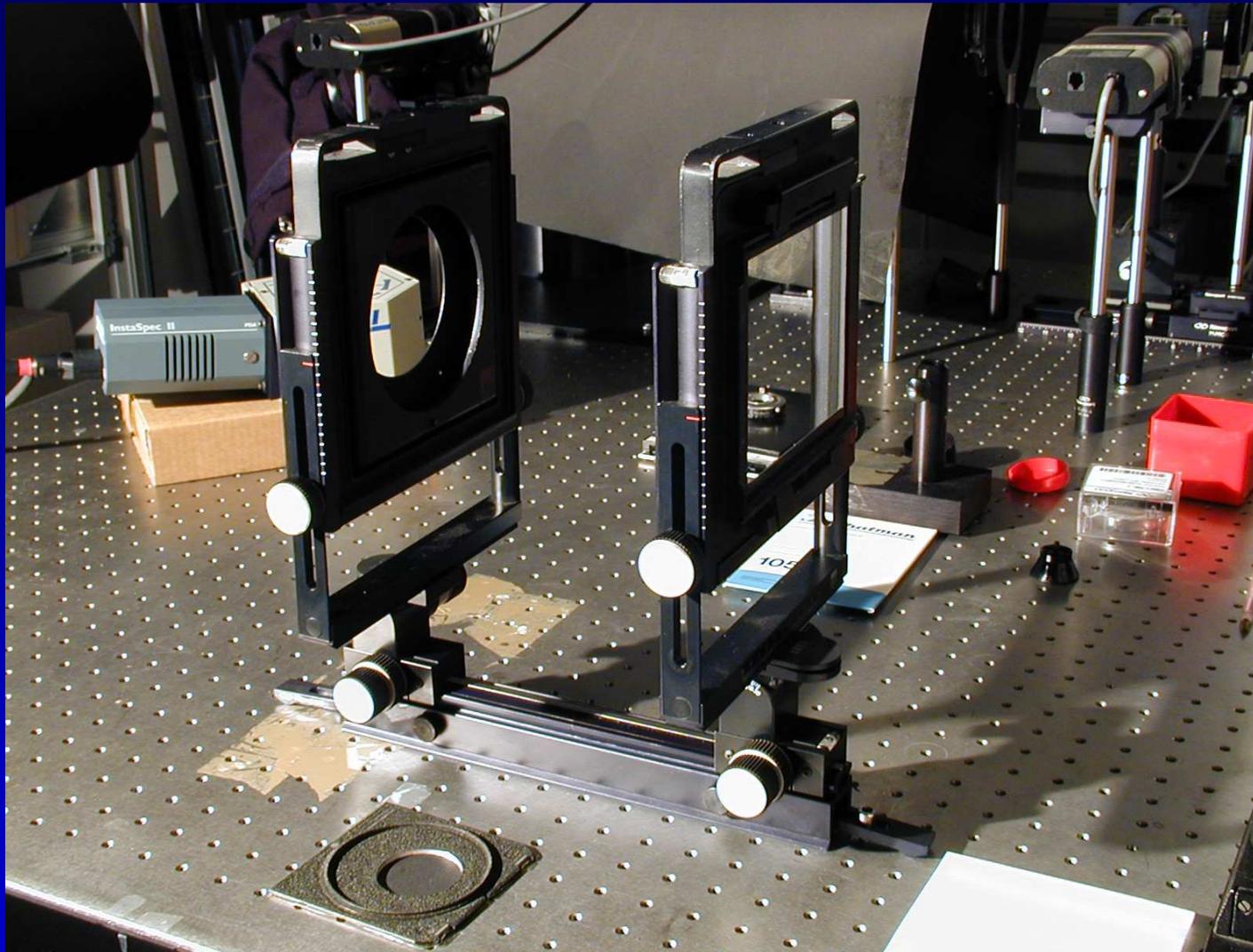
Drawing of the photocamera CARDIFF mounted on a rail, and fixed on an optical bench.

# PHOTOCAMERA CARDIFF



The CARDIFF photocamera has been realized in collaboration with the Studio Granata (Naples).

# PHOTOCAMERA CARDIFF



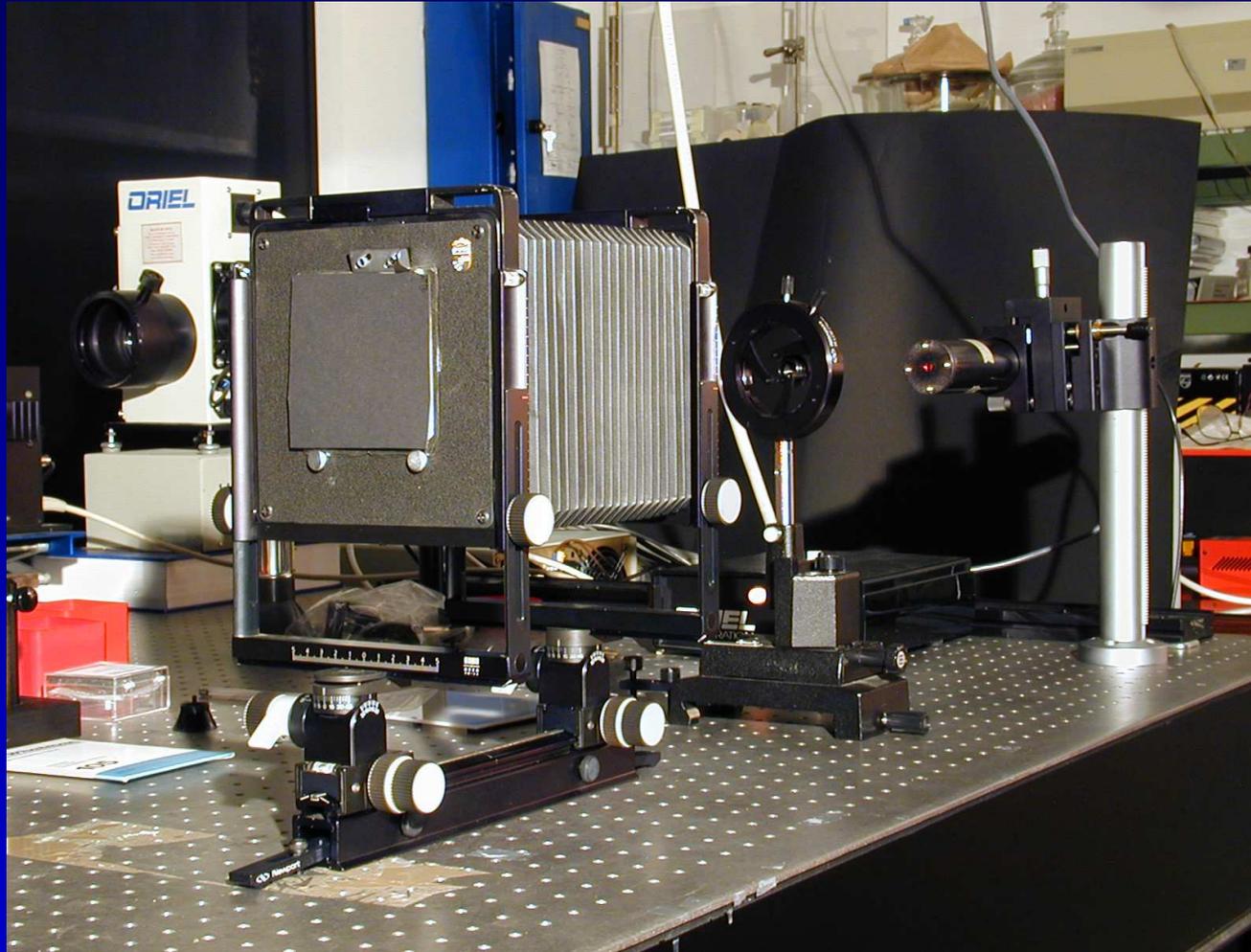
The photcamera CARDIFF is shown open.

# PHOTOCAMERA CARDIFF



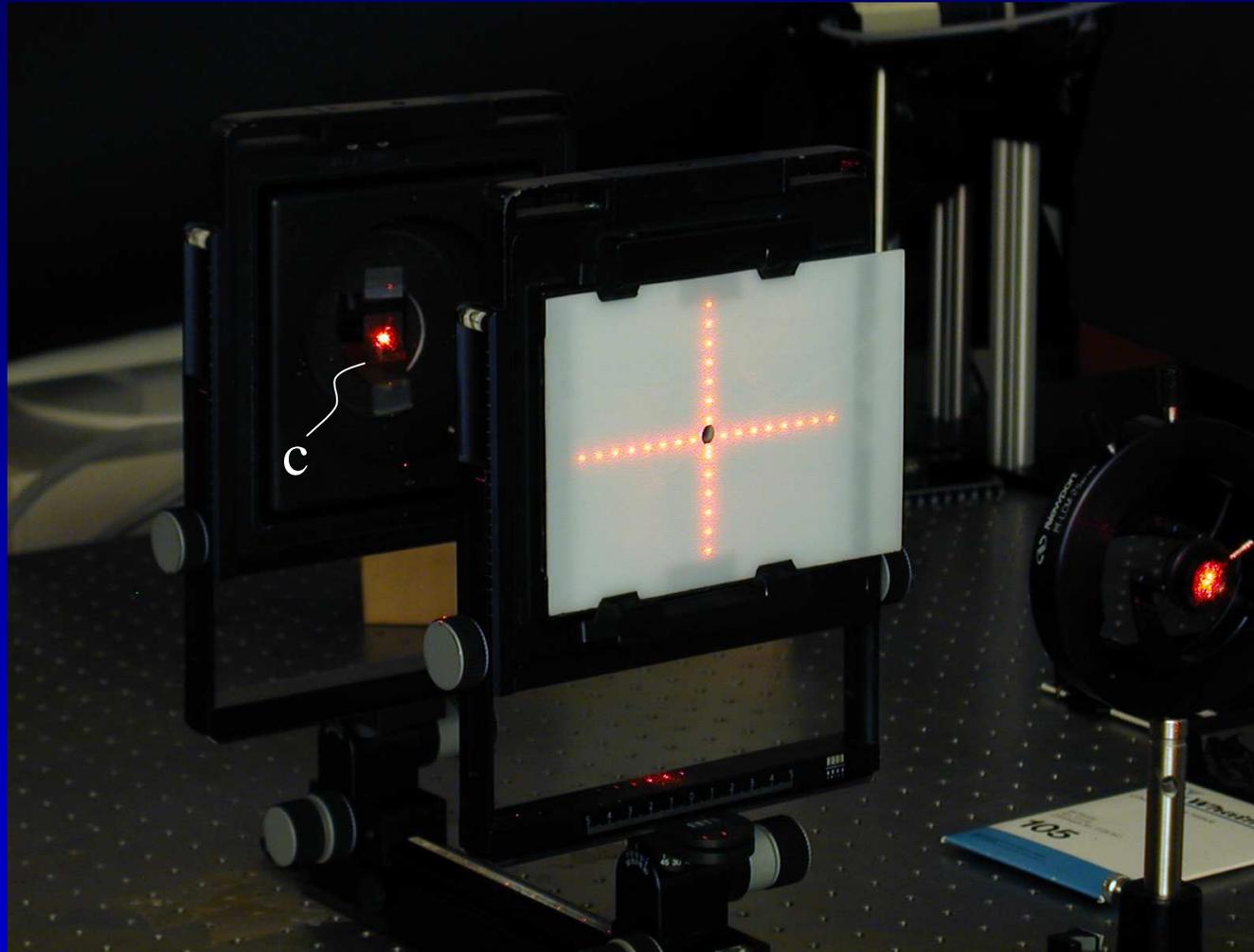
Photocamera CARDIFF assembled for measurements (front side).

# PHOTOCAMERA CARDIFF



Photocamera CARDIFF assembled for measurements (back side).

# PHOTOCAMERA CARDIFF



Alignement of the photocamera components by using a frosted glass screen.  
It is shown the light diffraction figure (LDF) produced by a PERL cell.

# CHARACTERIZATION OF SMALL TEXTURED SAMPLES

## Conditions:

He-Ne laser  $\lambda = 632.8$  nm,  $P = 25$  mW;

Sample-plate distance:  $d = 170$  mm;

Exposed area: 120 x 95 mm;

Exposition time:  $t_0 \approx 100$  msec;

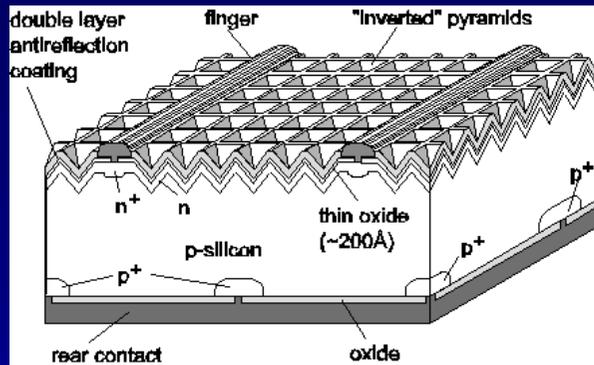
Use of neutral filter;

Photographic plate: panchromatic paper ( $\lambda > 580$  nm);  
orthochromatic paper ( $\lambda = 400-580$  nm).

N°	Sample	d(mm)	Texture	Notes
1	PERL	170	Inverted pyramids	Beam on grid
2	“	“	“	Beam on Si
3	“	“	“	Beam on grid
4	PYR	“	“	Beam on Si
5	HC	“	Hemispherical wells	Beam on Si
6	“	“	“	Beam on grid
7	“	“	“	“
8	m-Si	“	Right upright pyramids	“
9	p-Si	“	nanoporosity	Beam on Si
10	PERL module	“	Inverted pyramids	Beam on grid
11	“	“	“	“

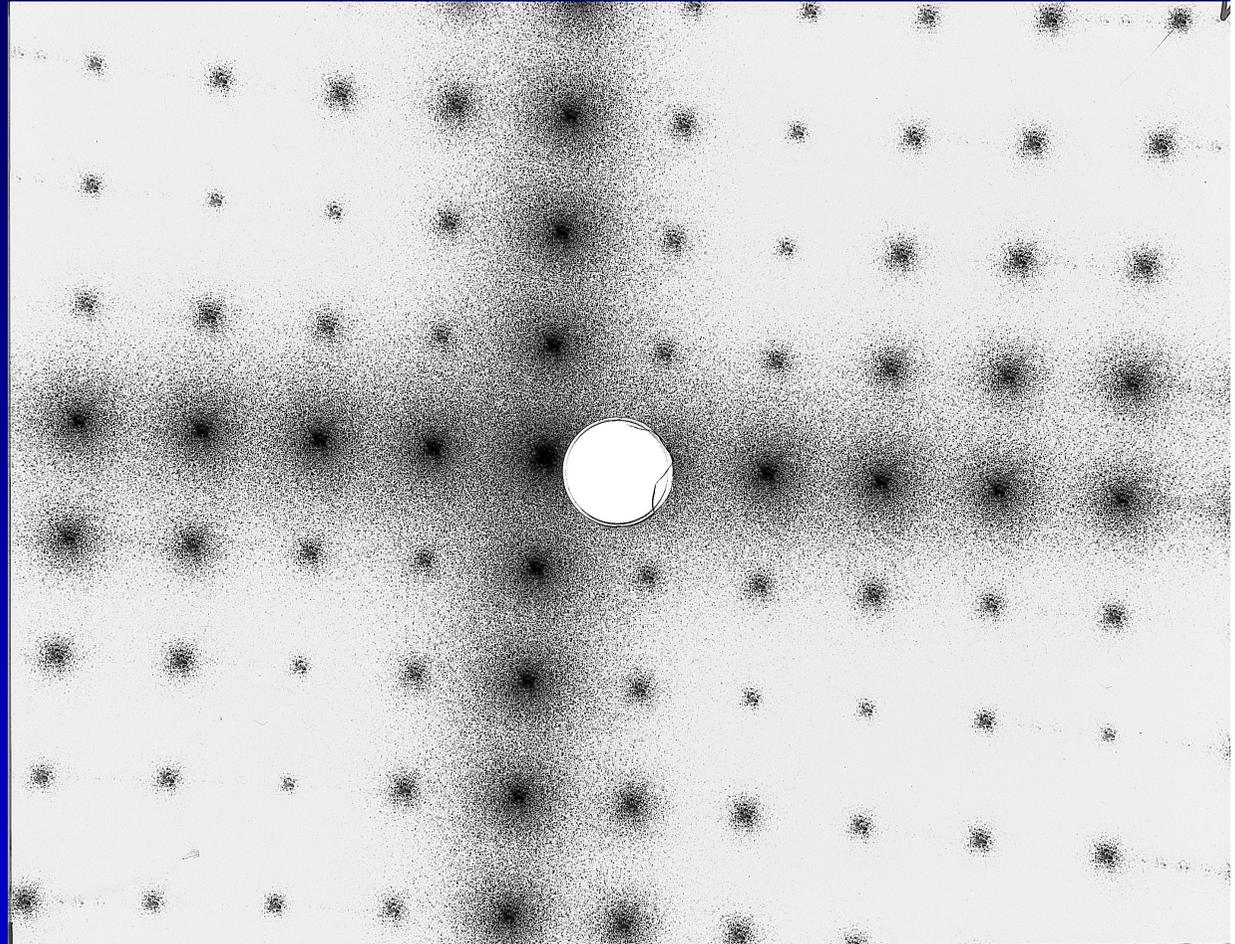
Table of characterized samples.

# INVERTED PYRAMIDS TEXTURE



Mono-Si cell (PERC)  
from UNSW  
( $\eta = 24.4\%$ ).

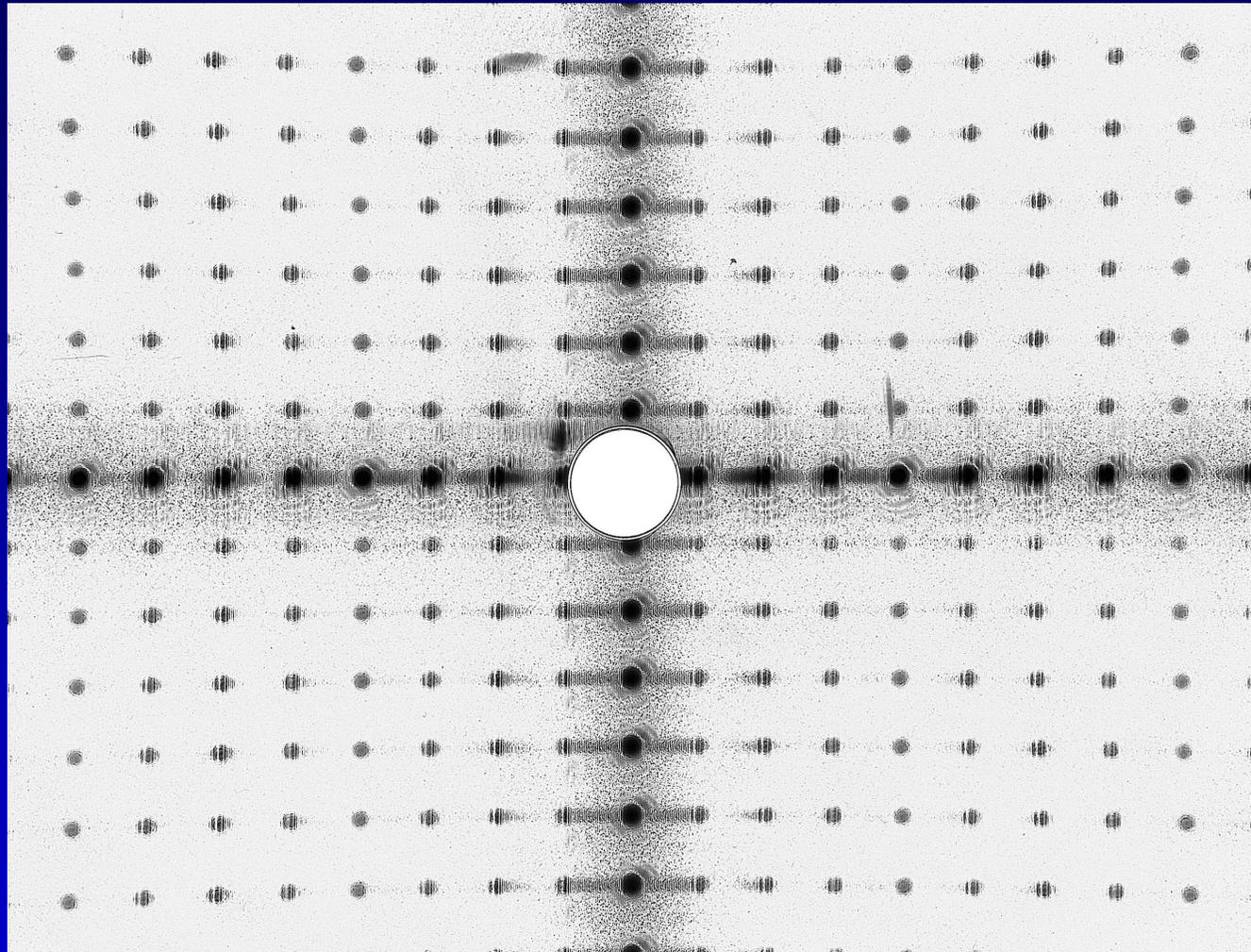
Texture: square lattice of  
inverted pyramids, realized  
by photolithography with  
*anisotropic* etching of the  
(100) Si surface.



Negative of the light diffraction figure (LDF).  
The central hole on the plate is for the passage  
of the incident light beam.

# INVERTED PYRAMIDS TEXTURE

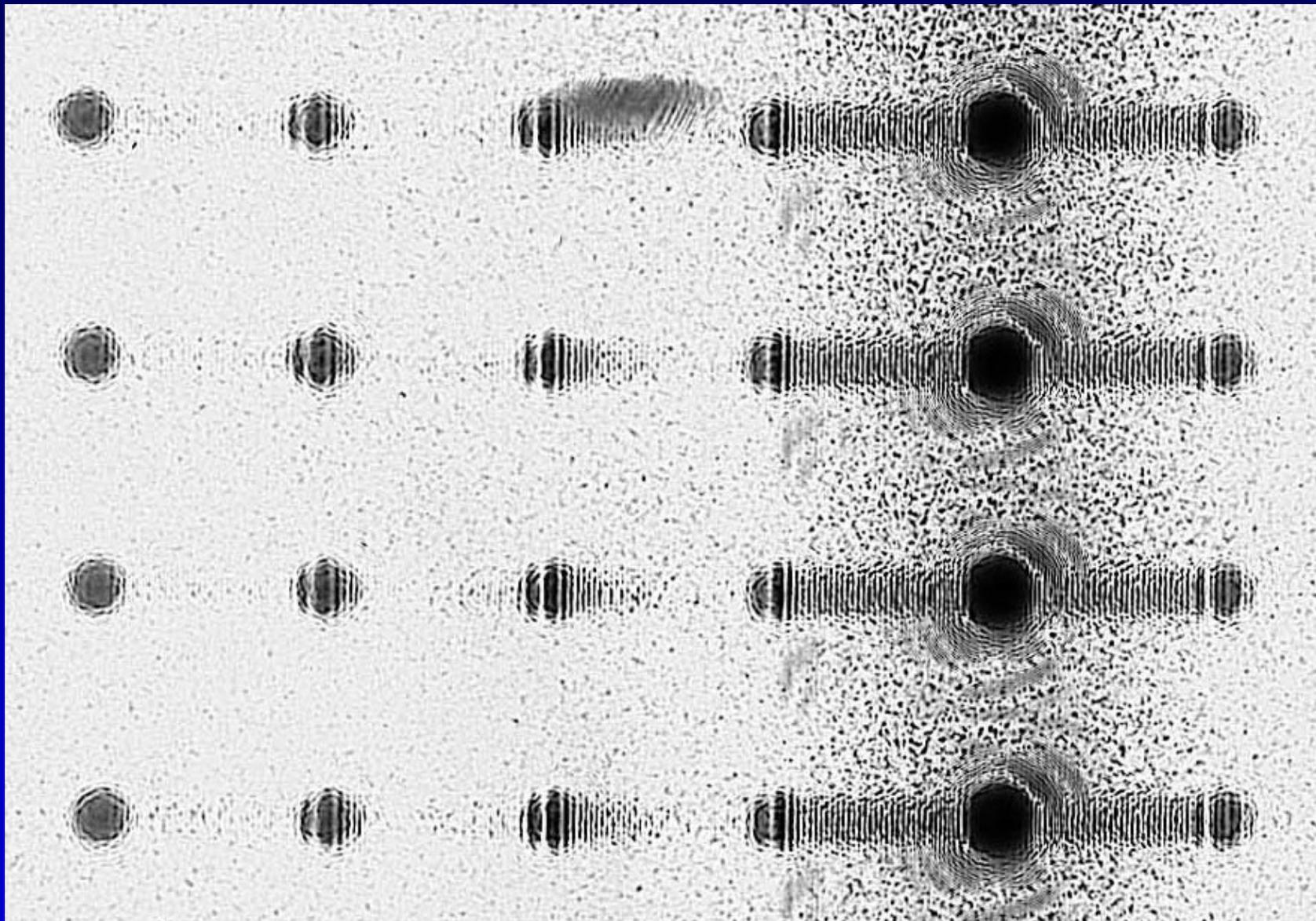
95 mm



120 mm

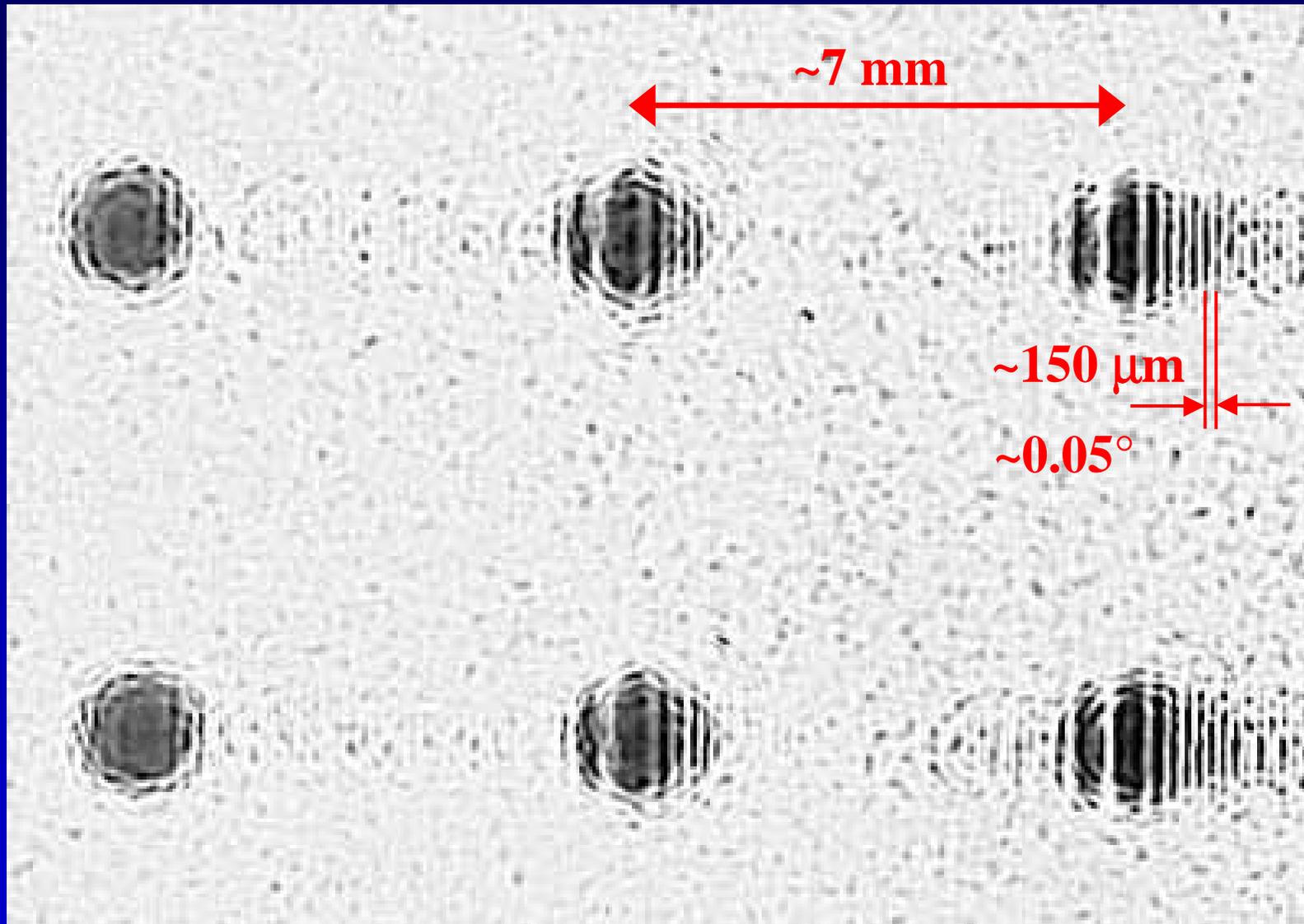
Light Diffraction Figure (LDF) of a PERL cell.

# INVERTED PYRAMIDS TEXTURE



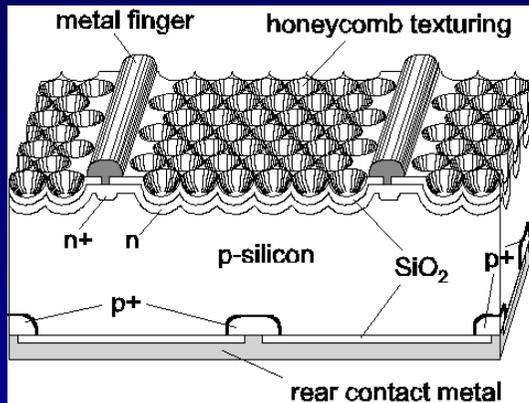
Particular of the LDF of a PERL cell

# INVERTED PYRAMIDS TEXTURE



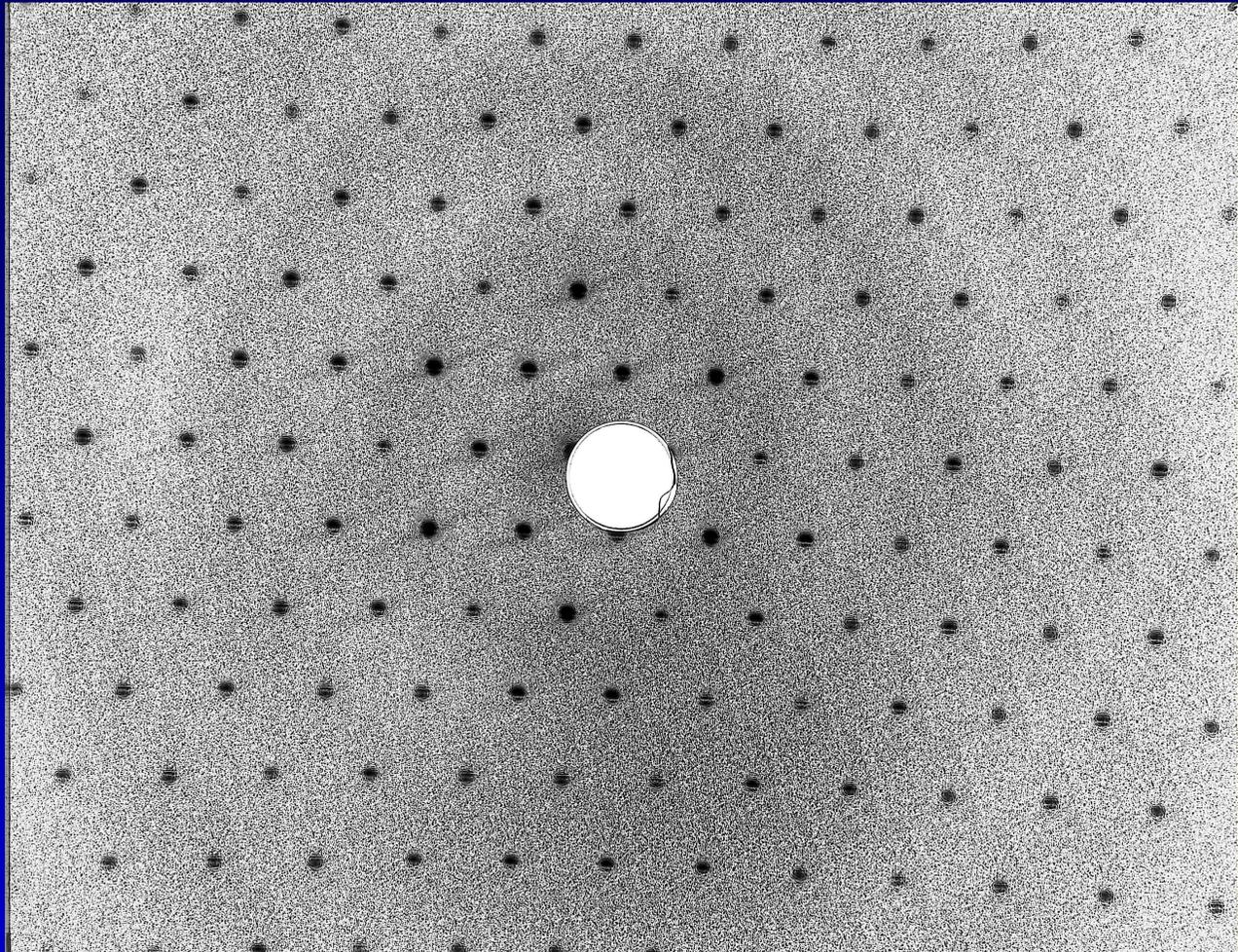
Particular of the LDF of a PERL cell

# HONEYCOMB TEXTURE



Multi-Si cell from UNSW  
( $\eta = 19.8\%$ ).

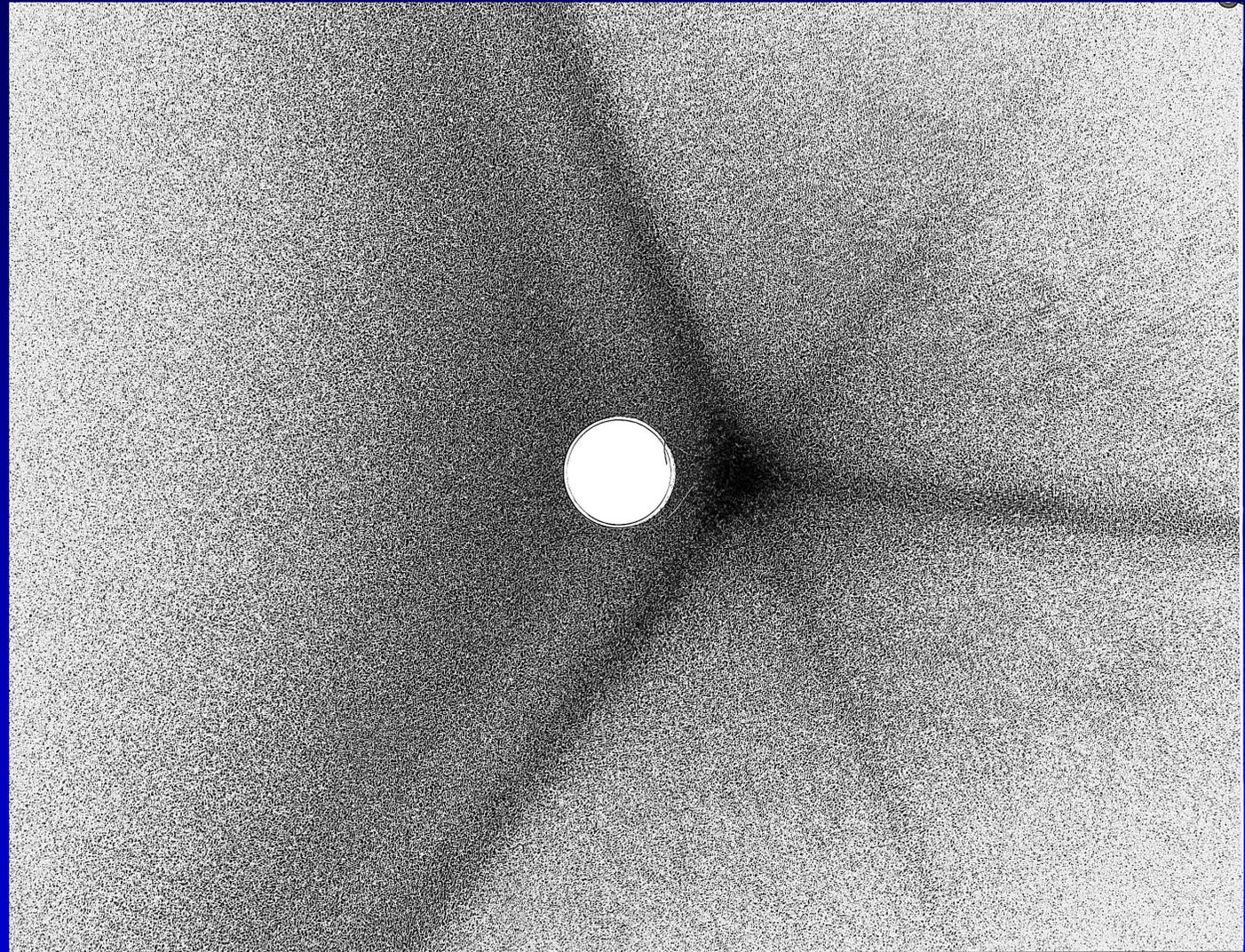
Texture: honeycomb lattice of hemispherical wells, realized by photolithography with *isotropic* etching of the multi-Si surface.



Negative of the light diffraction figure (LDF).

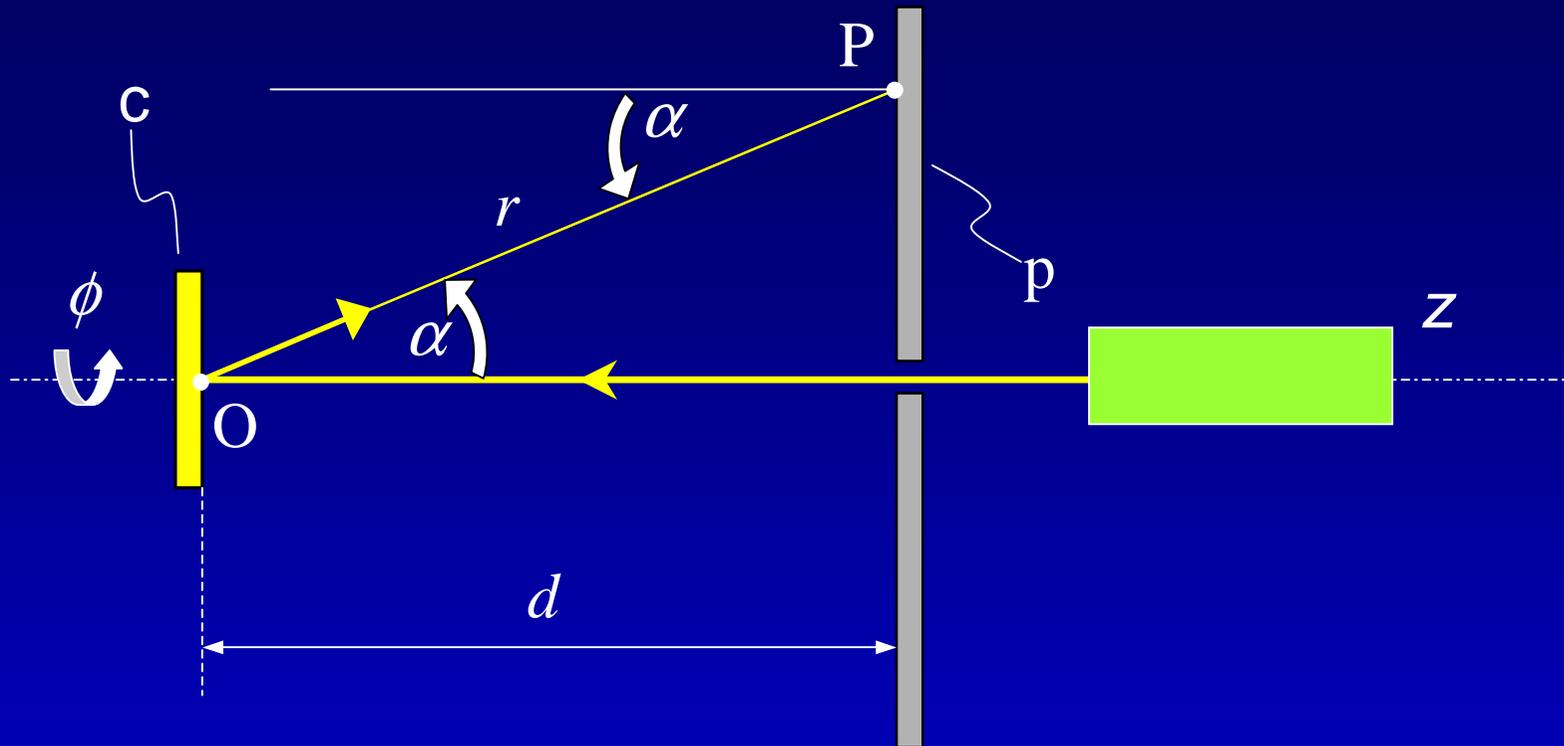
# PHOTOCAMERA CARDIFF

Mono-Si cell from  
Eurosolare  
( $\eta = \%$ ).  
Texture: random  
upright  
pyramids, realized  
by *anisotropic*  
etching of the  
(100) Si surface.



Negative of the light diffraction figure (LDF).

# ANALYSIS OF THE SCATTERED LIGHT (plane geometry)



$$G_{abs}(d, \alpha, \lambda) \propto G_{scat}^{\perp} \cdot \frac{1}{r^2} \cdot \cos \alpha [1 - R(\alpha, \lambda)]$$

$$G_{abs}(d, \alpha, \lambda) \propto G_{scat}^{\perp} \cdot \frac{1}{d^2} \cdot \cos^3 \alpha [1 - R(\alpha, \lambda)]$$

## ANALYSIS OF THE SCATTERED LIGHT (plane geometry)

$$G_{abs}(d, \alpha, \lambda, t) \propto G_{scat}^{\perp} \cdot \frac{1}{d^2} \cdot \cos^3 \alpha [1 - R(\alpha, \lambda, t)]$$

$$0 \leq t \leq t_0 \quad t_0 = \textit{exposition time}$$

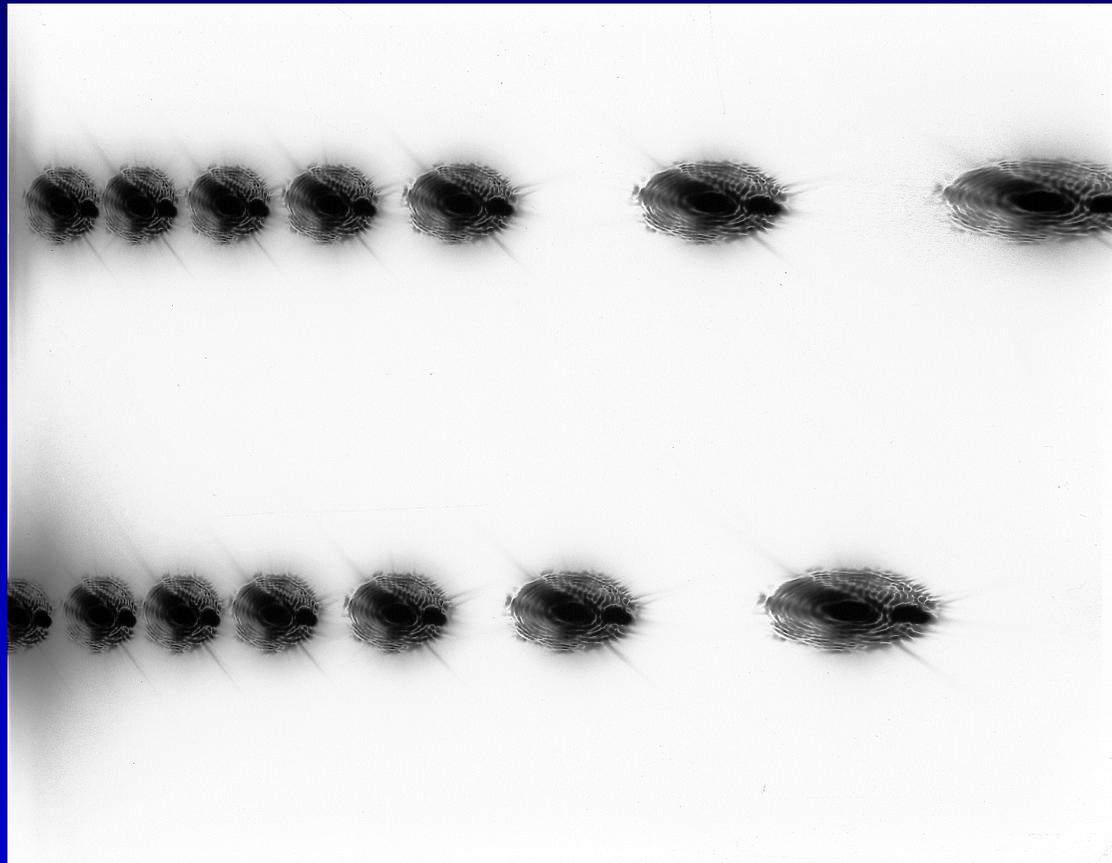
$$\bar{G}_{abs}(d, \alpha, \lambda, t) \propto G_{scat}^{\perp} \cdot \frac{1}{d^2} \cdot \cos^3 \alpha [1 - \bar{R}(\alpha, \lambda, t_0)]$$

*At a first approximation, the plate reflectivity can be assumed constant with respect to  $\alpha$  :*

$$\bar{G}_{abs}(d, \alpha, \lambda, t_0) \propto G_{scat}^{\perp} \cdot \frac{1}{d^2} \cdot \cos^3 \alpha [1 - \bar{R}(\lambda, t_0)]$$

# ANALYSIS OF THE SCATTERED LIGHT (plane geometry)

Work is in progress in order to measure the reflectance properties of the photographic plate as a function of  $\lambda$ ,  $\alpha$  and  $t_0$ .



Example of a test performed to study the variation of contrast as function of the angle of incidence of a 633 nm laser beam.

**OTHER DESIGNS OF THE  
CARDIFF PHOTOCAMERA**



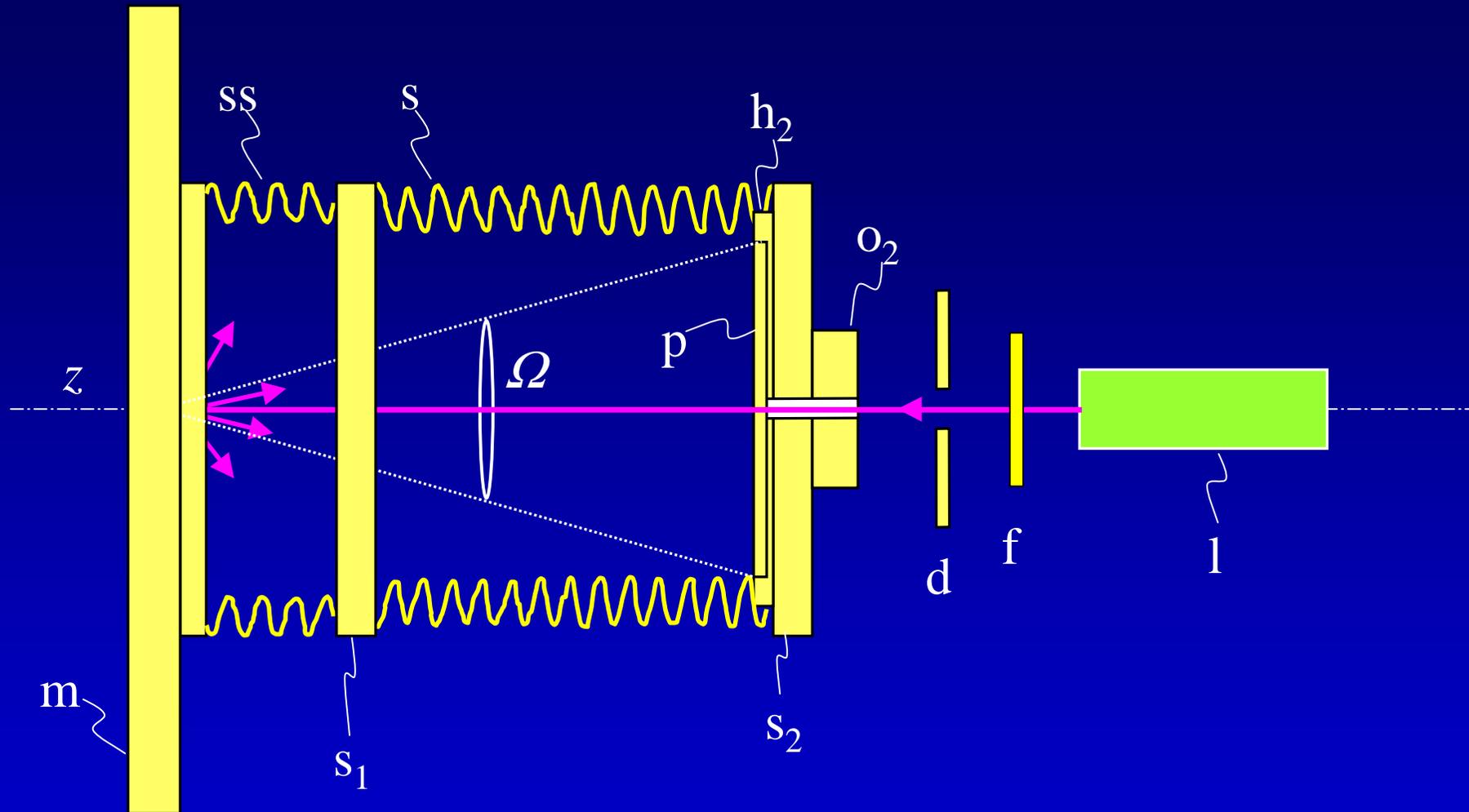
## ANALYSIS OF THE SCATTERED LIGHT (cylindrical geometry)

$$G_{abs}(d, \lambda, t) \propto G_{scat}^{\perp} \cdot \frac{1}{R^2} \cdot [1 - R(90^{\circ}, \lambda, t)]$$

$$0 \leq t \leq t_0 \quad t_0 = \textit{exposition time}$$

$$\overline{G}_{abs}(d, \lambda, t_0) \propto G_{scat}^{\perp} \cdot \frac{1}{R^2} \cdot [1 - \overline{R}(90^{\circ}, \lambda, t_0)]$$

# REFLECTION FROM LARGE SAMPLES



For the characterization of large samples (PV modules) a supplementary bellow is inserted on the back of the photocamera.



## CONCLUSIONS

- ☺ A camera, CARDIFF, for recording the light scattered from textured PV samples has been presented.
- ☺ CARDIFF can work in reflection, in transmission, on small and large samples.
- ☺ CARDIFF can be designed in order to collect light on a plane or cylindrically shaped photographic plate.
- ☺ CARDIFF produces a negative film which can be scanned and transferred to a computer for analysis of the scattered image.

***Thanks a lot  
for your attention***